



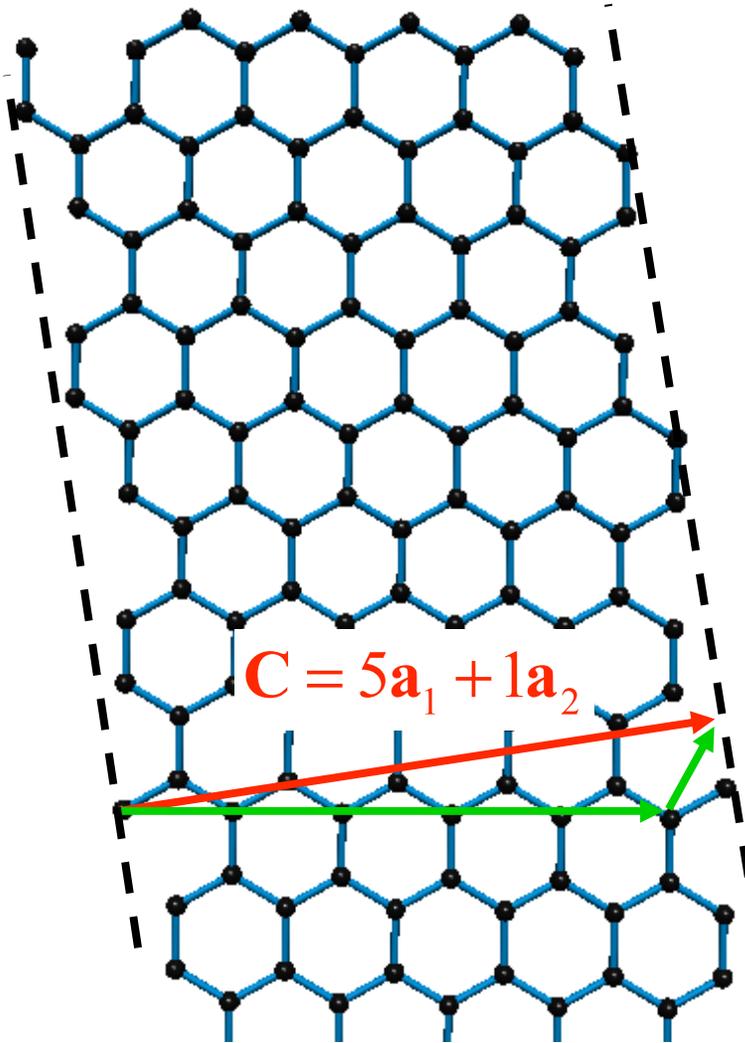
# Putting Things on Top of Other Things: Assembly of Graphene and Carbon Nanotube Devices by Mechanical Transfer

J. Hone

Columbia University  
Dept. of Mechanical Engineering  
Nanoscale Science and Engineering Center



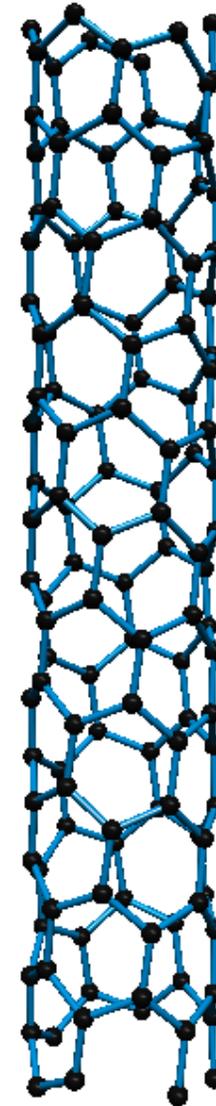
# Nanotubes: Crystal Structure



(5,1) SWNT



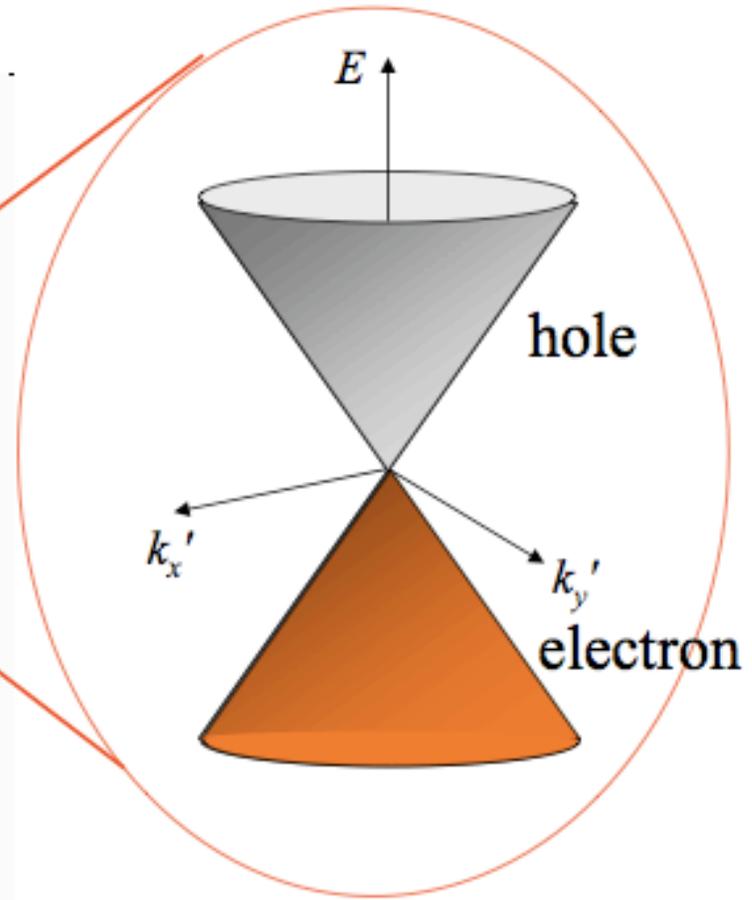
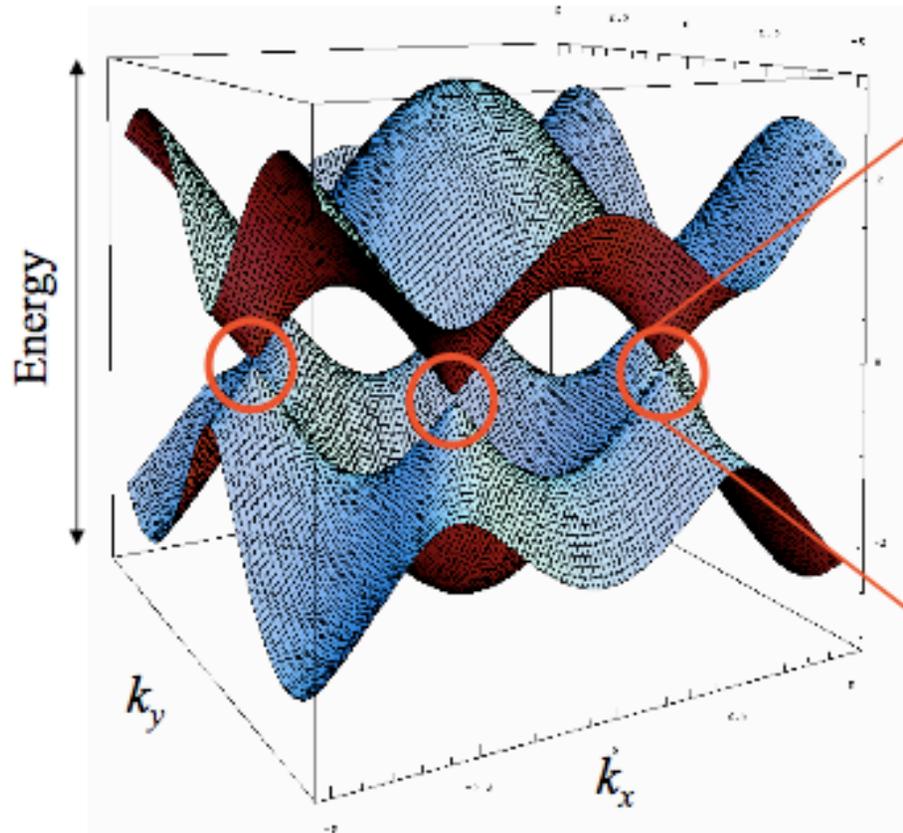
(n,m) chiral indices uniquely determine nanotube crystal structure





# Physical and Electronic Structure

Band structure of graphene (Wallace 1947)

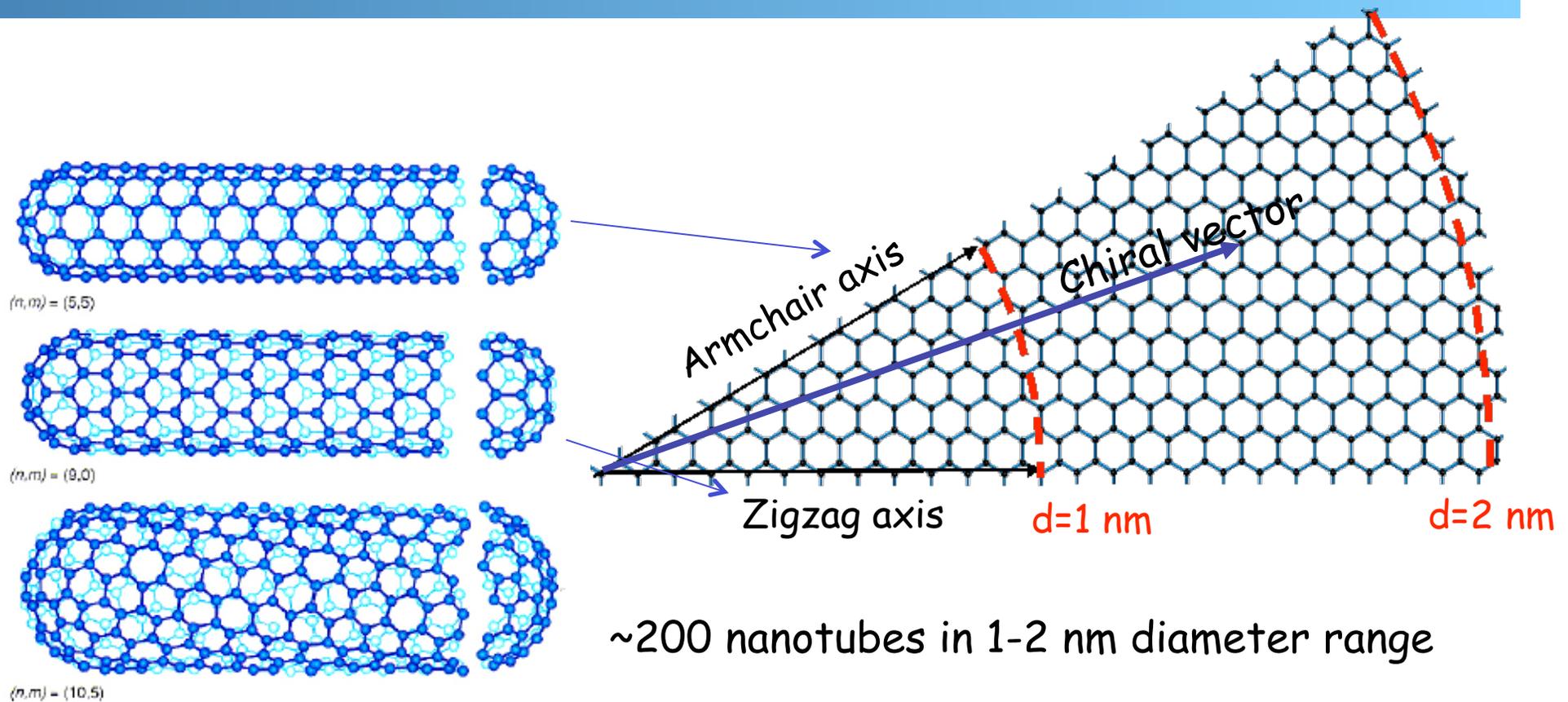


$$E \approx \hbar v_F \left| \vec{k}'_{\perp} \right|$$

Zero effective mass particles moving with a constant speed  $v_F$



# How many different structures?



~200 nanotubes in 1-2 nm diameter range

2/3 semiconducting

1/3 metallic

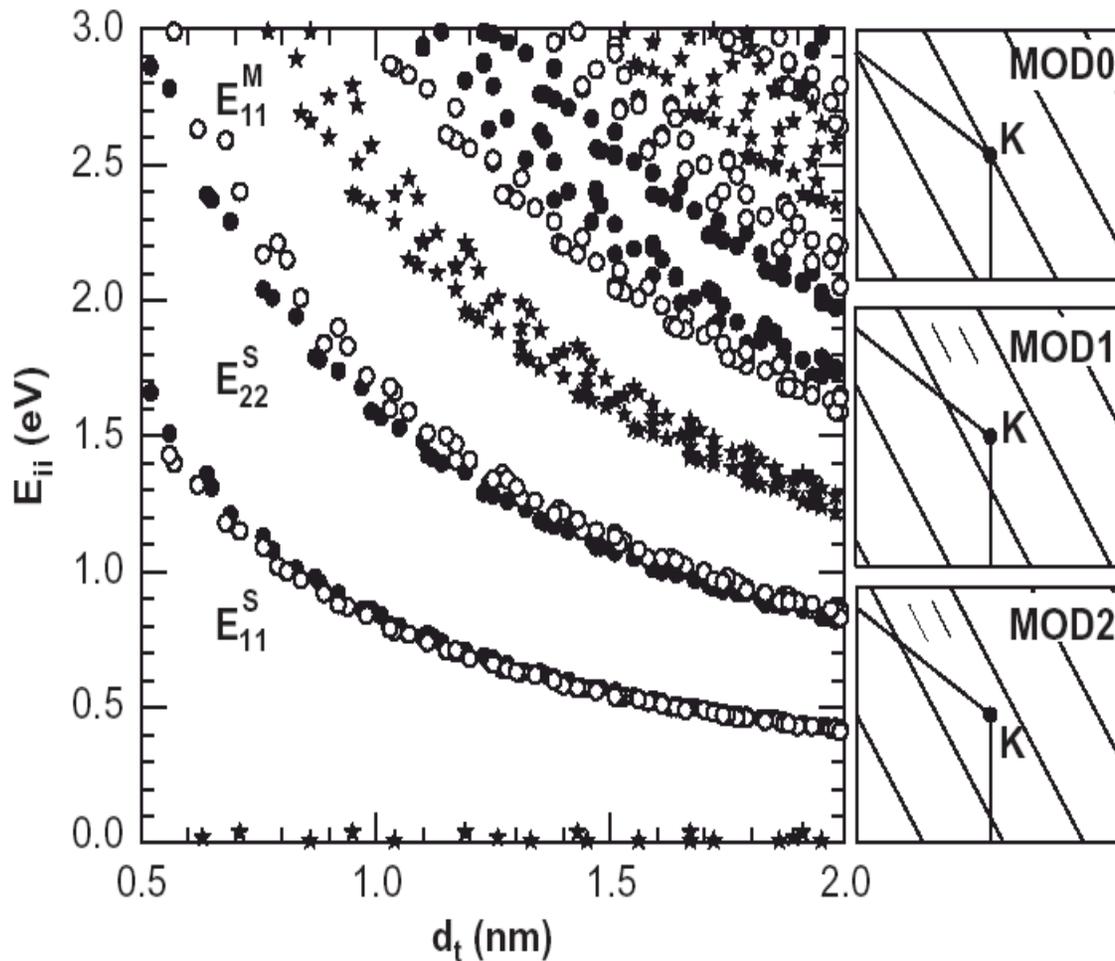
$$E_g \approx 800 \text{ meV}/d(\text{nm})$$

→  $(n,n)$  armchair  $E_g=0$

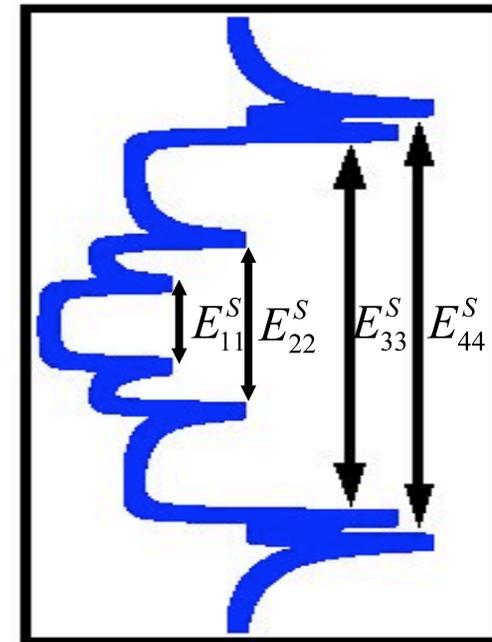
↘  $n \neq m$  'chiral metal'  $E_g \approx 5\text{-}20 \text{ meV}$



# Identifying the Crystal Structure



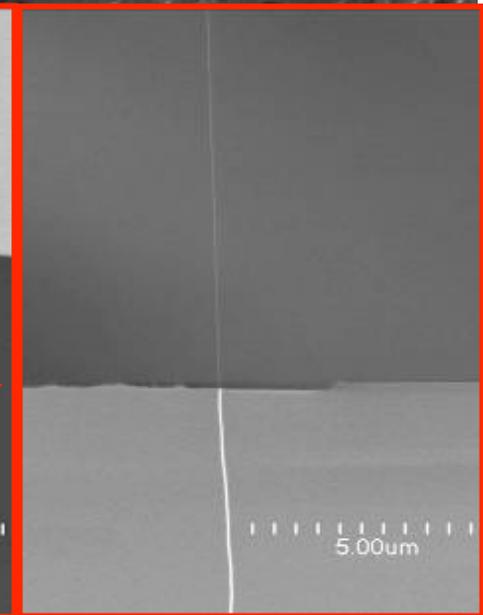
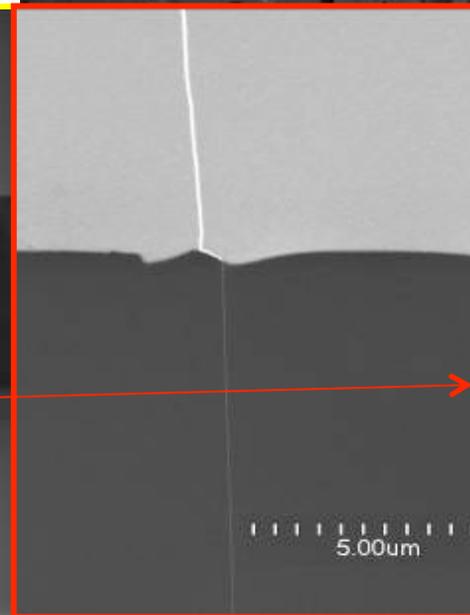
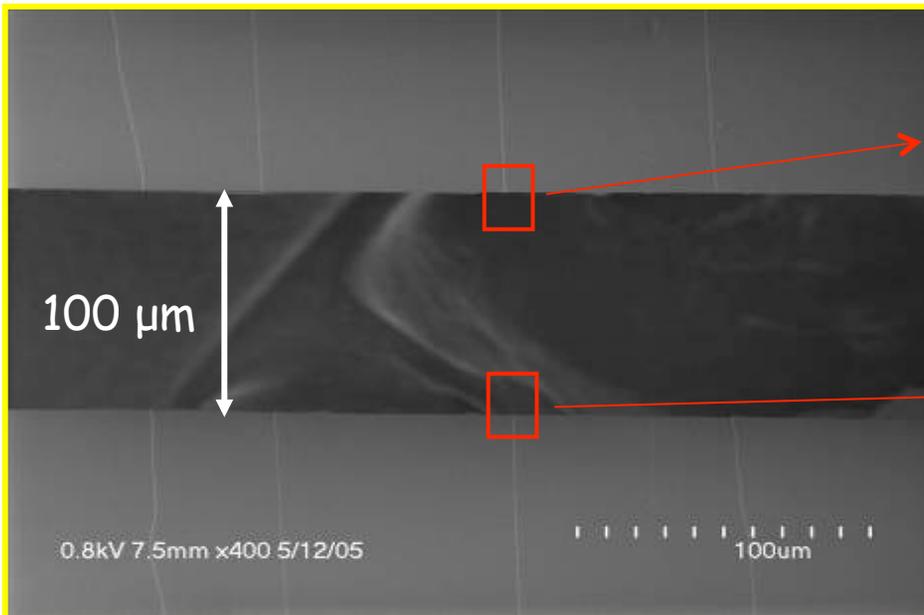
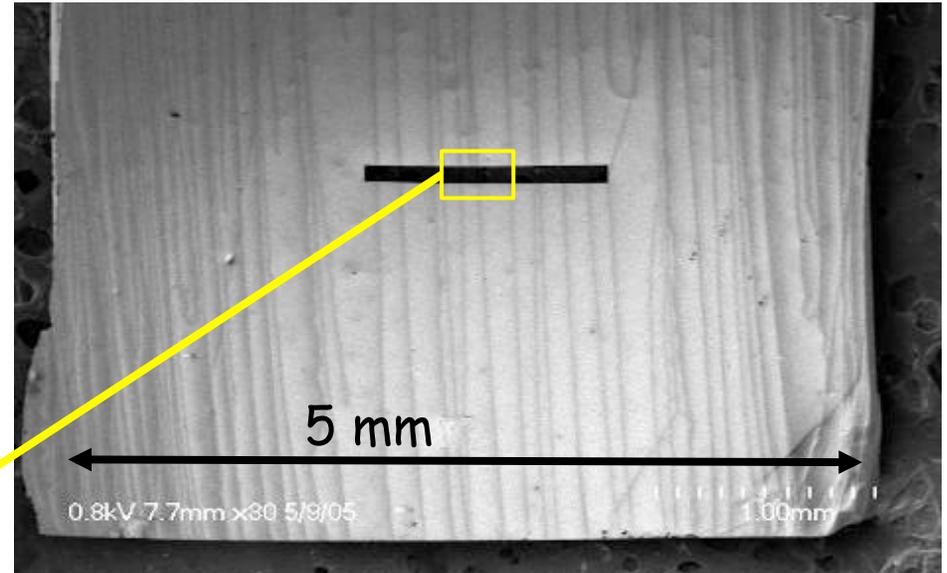
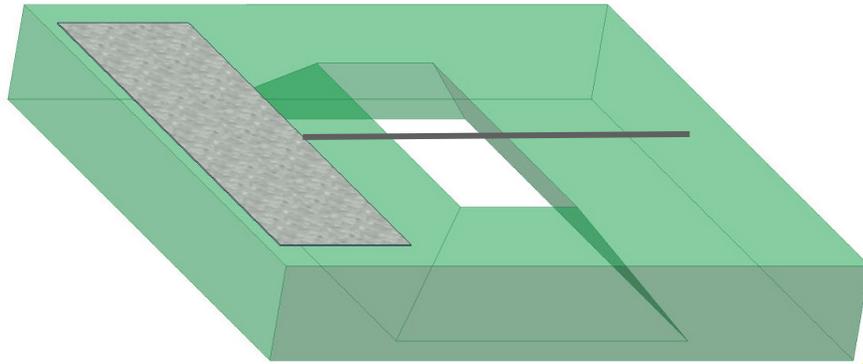
Series of optical transitions should provide a unique fingerprint for each nanotube



allowed optical transitions for nanotubes in the 0.5-2 nm diameter range

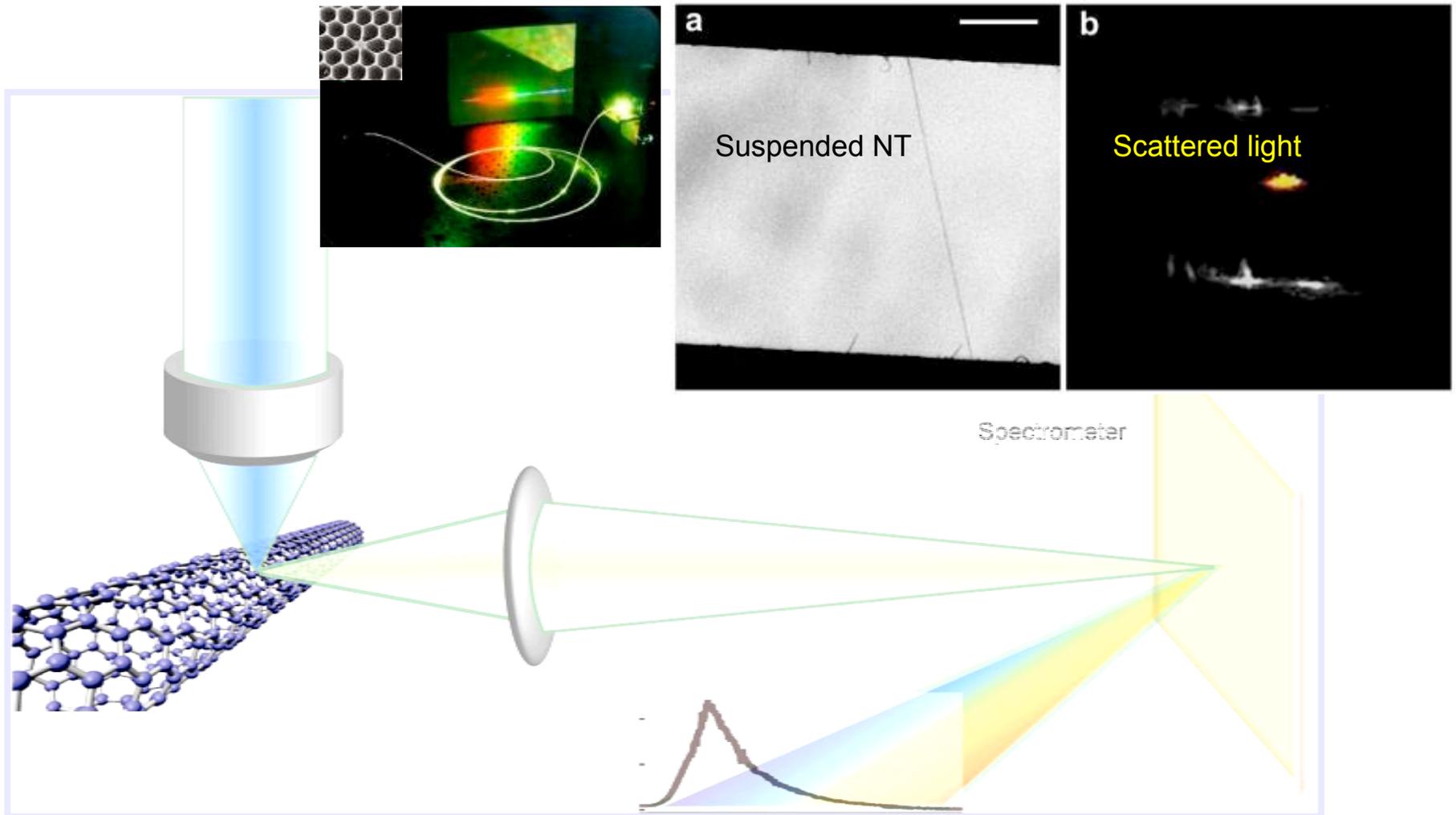


# Suspended Nanotubes for Single-Tube Spectroscopy





# Rayleigh Scattering Spectroscopy



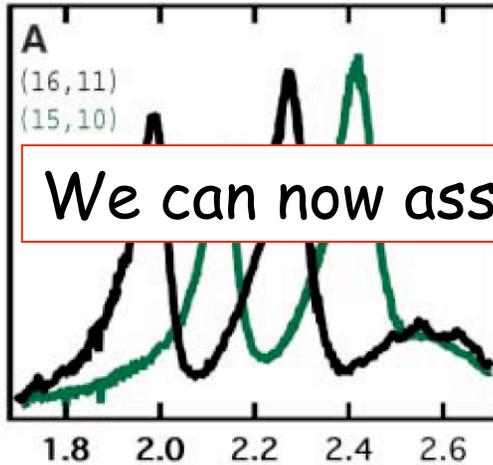
## ***Probing Electronic Transitions in Individual Carbon Nanotubes by Rayleigh Scattering***

Matthew Y. Sfeir, Feng Wang, Limin Huang, Chia-Chin Chuang, J. Hone, Stephen P. O'Brien, Tony F. Heinz, Louis E. Brus  
Science **306**, 1540-1543 (2004)

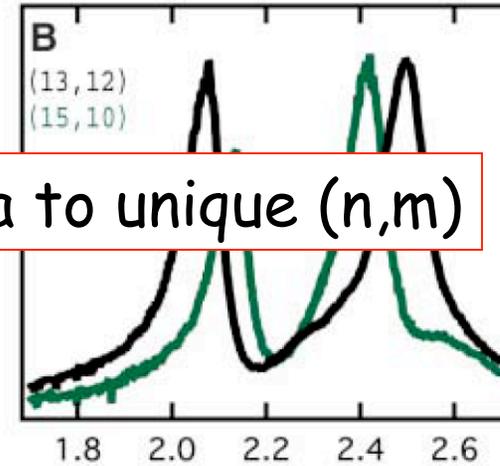


# TEM Structural Assignment

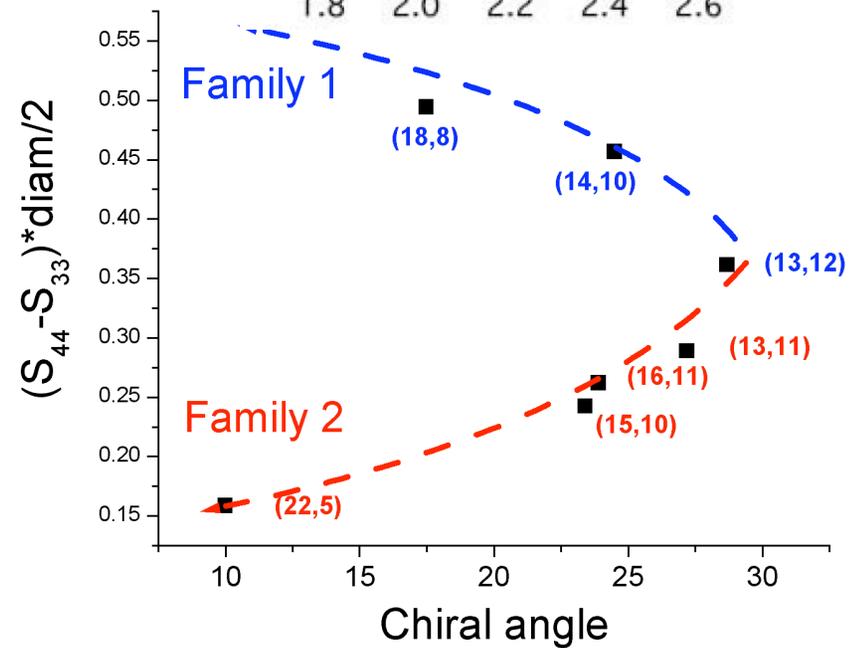
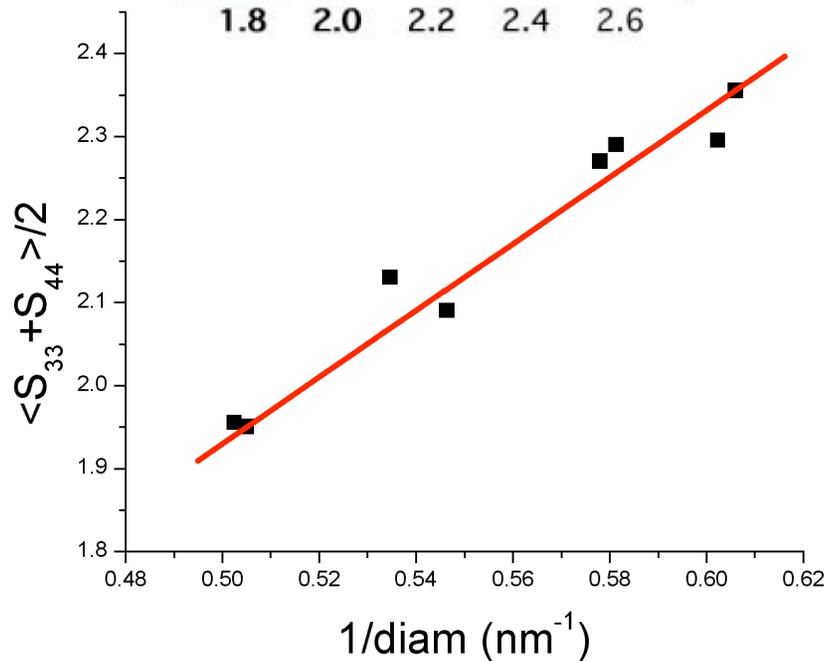
## Diameter Dependence



## Chiral Angle Dependence

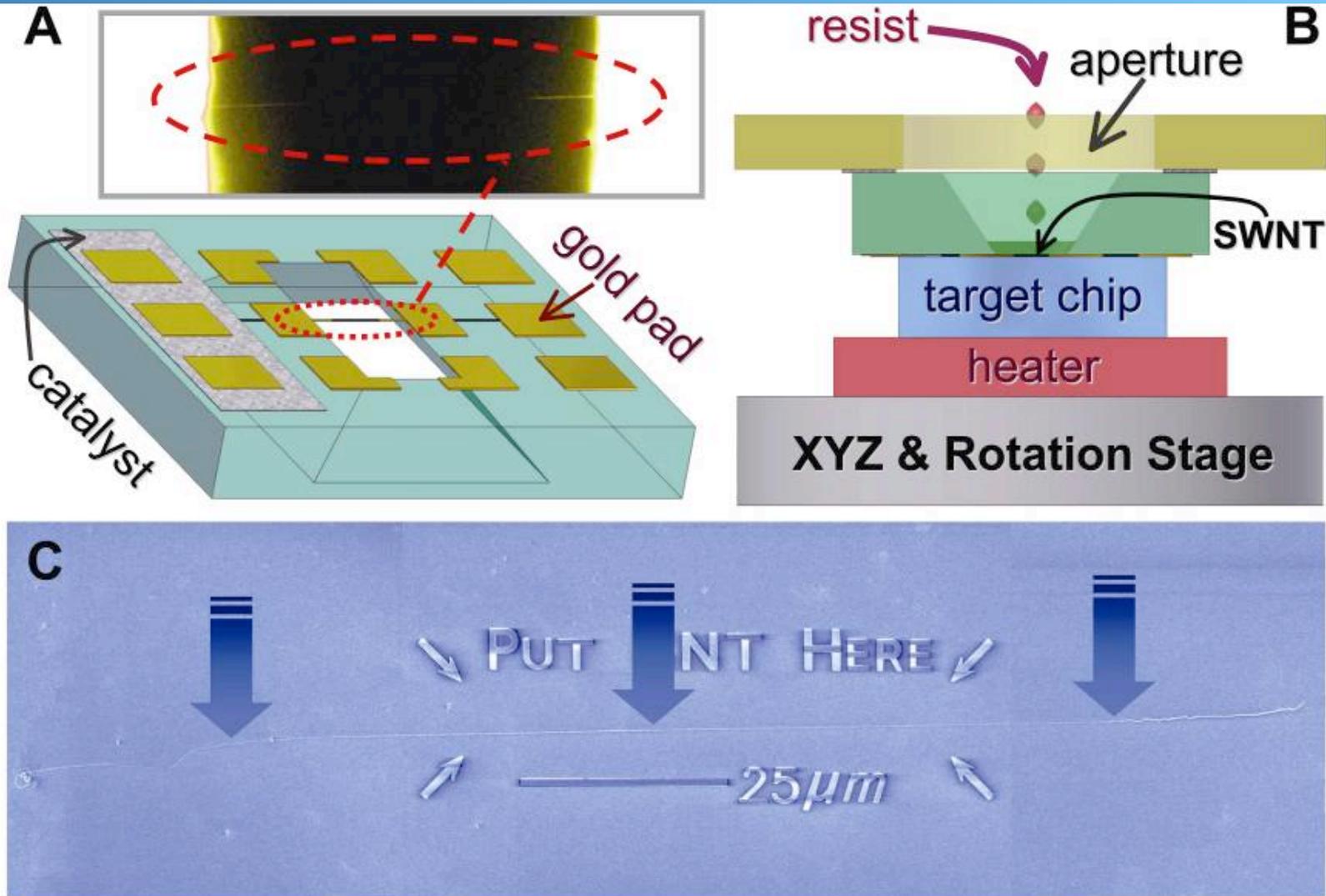


We can now assign most spectra to unique (n,m)





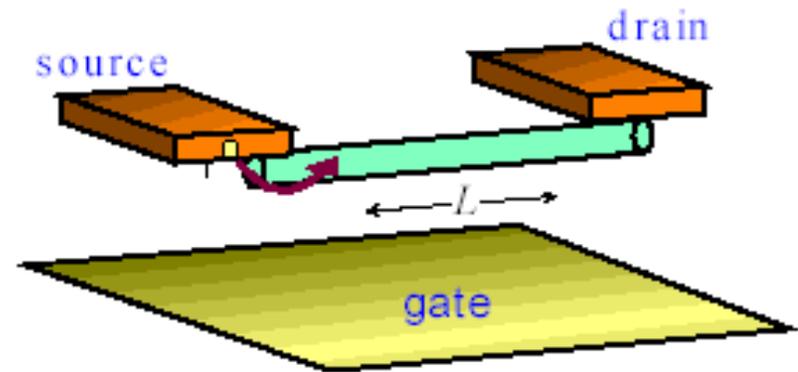
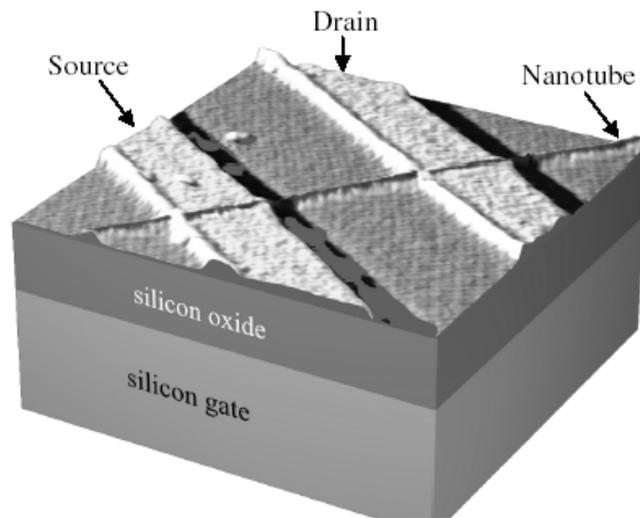
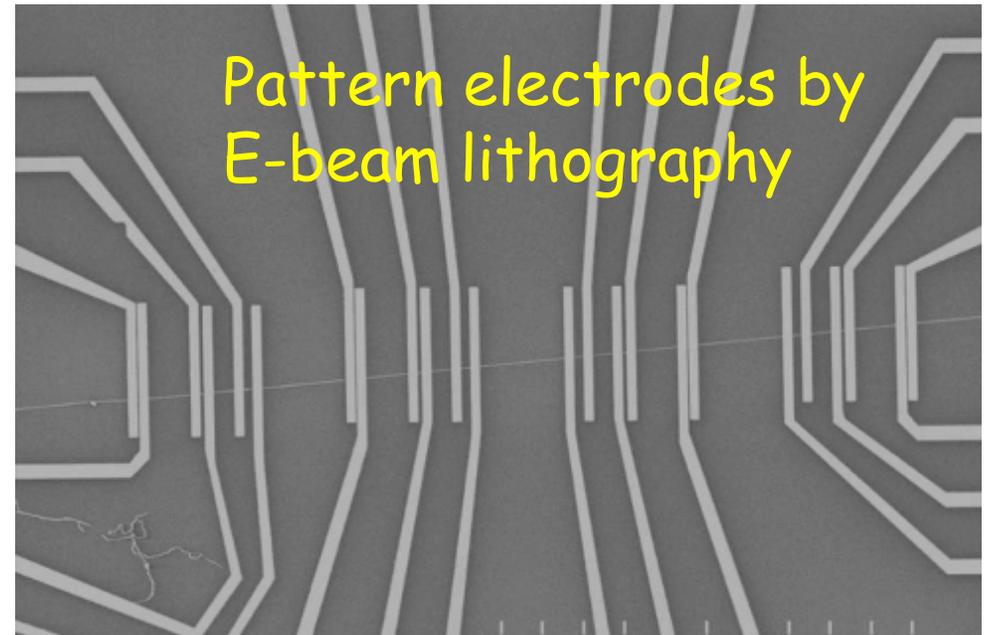
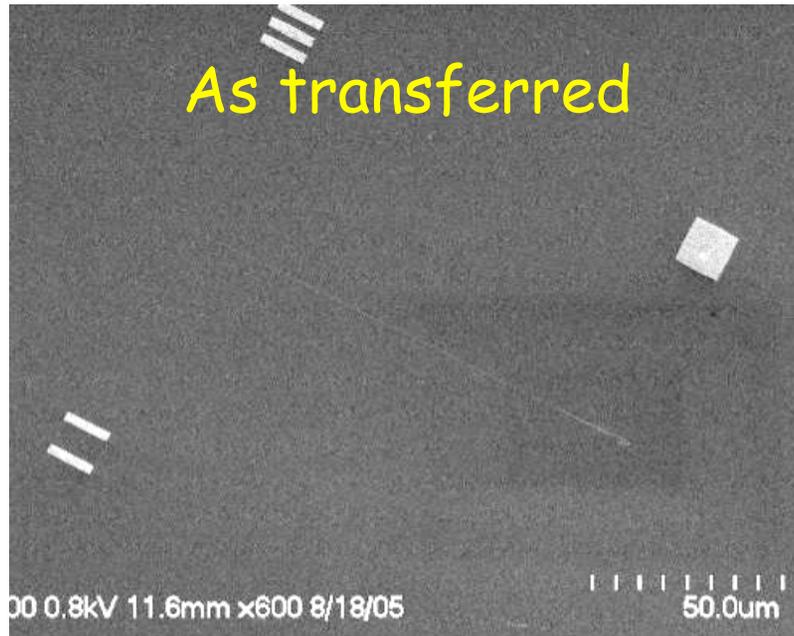
# Nanotube Transfer for Electrical Measurements



X.M.H. Huang, R. Caldwell, M. Huang, S.C. Jun, L. Huang, M. Sfeir, S. O'Brien, J. Hone. *Nano Letters* **5**, 1515-1518 (2005).



# Transferred SWNT

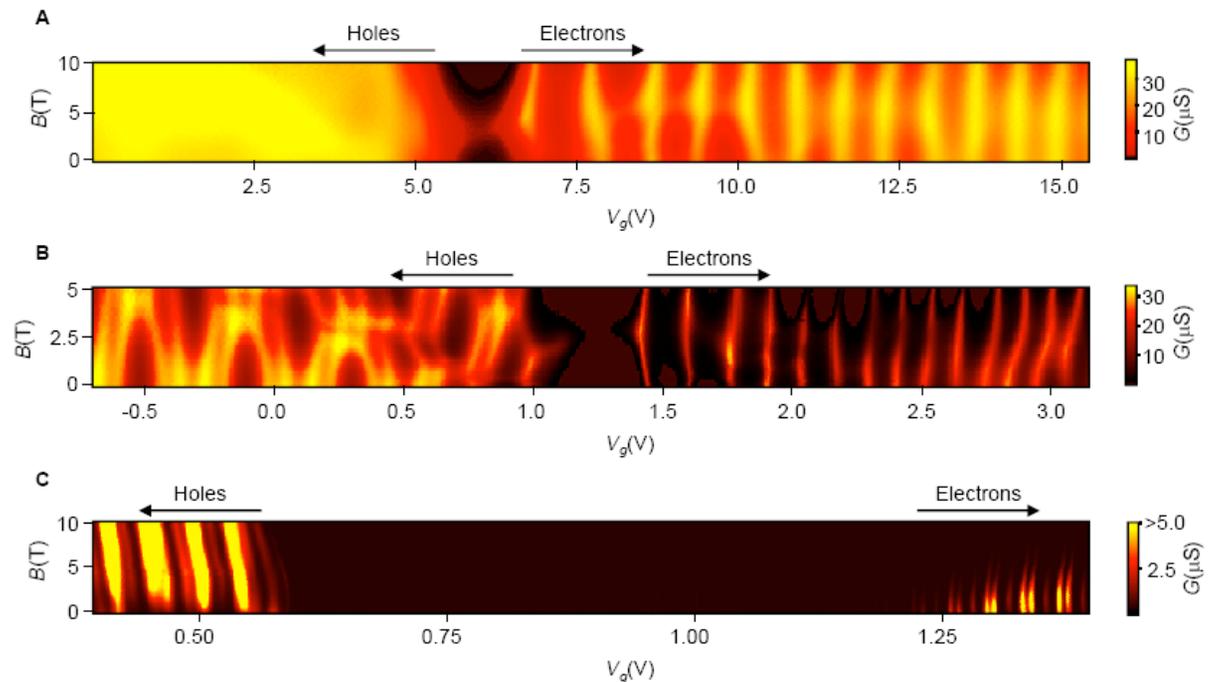
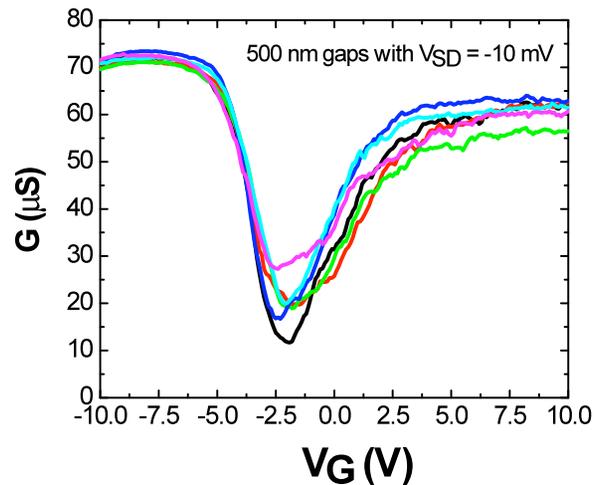


3-terminal electrical measurements<sup>W</sup>



## Are metallic tubes metallic?

'Armchair' tubes should be perfect metals... but we always see a 'gap'

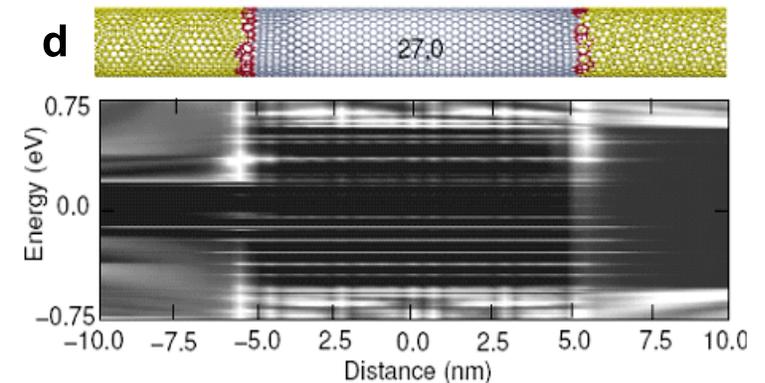
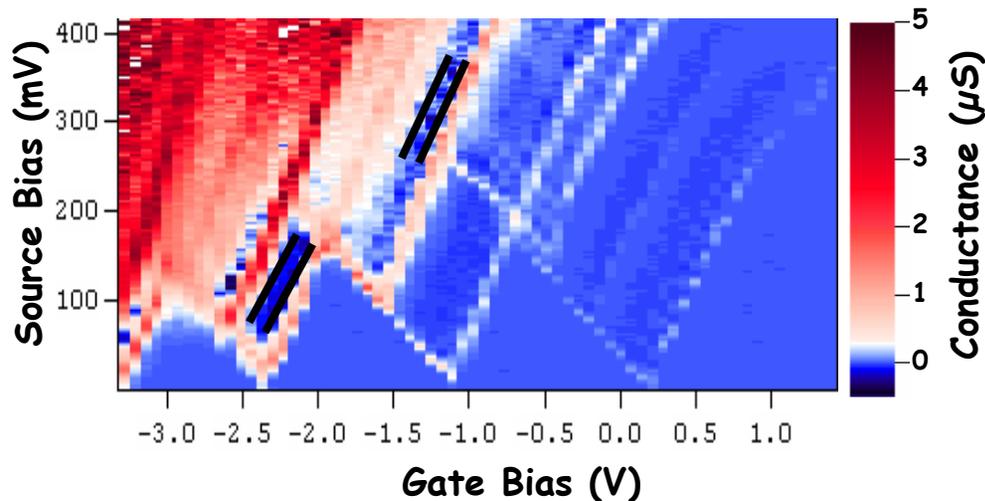
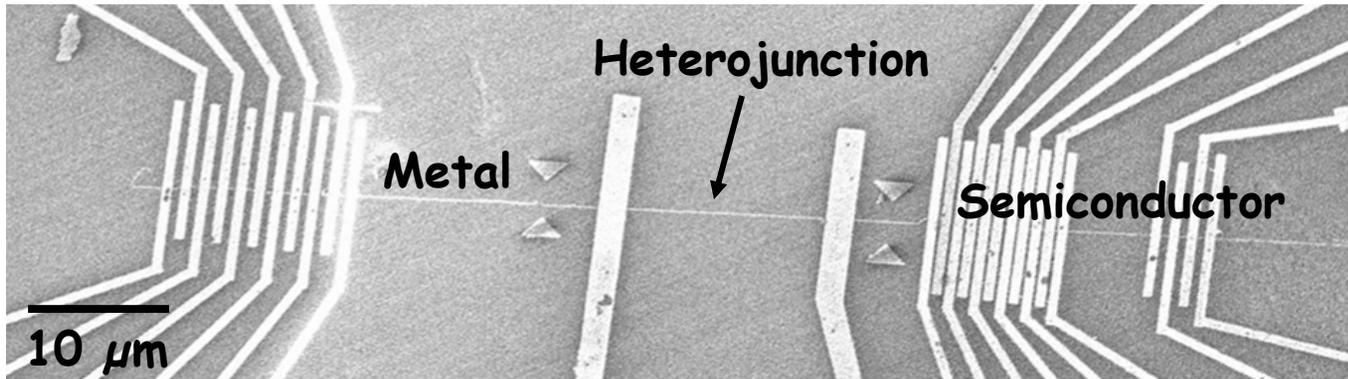


Explanation: electron-electron interactions cause insulating state at low charge density (Mott insulator). Highly unusual at room T!

Vikram V. Deshpande, Bhupesh Chandra, Robert Caldwell, Dmitry Novikov, James Hone, and Marc Bockrath, *Science* 323, 106 (2009).



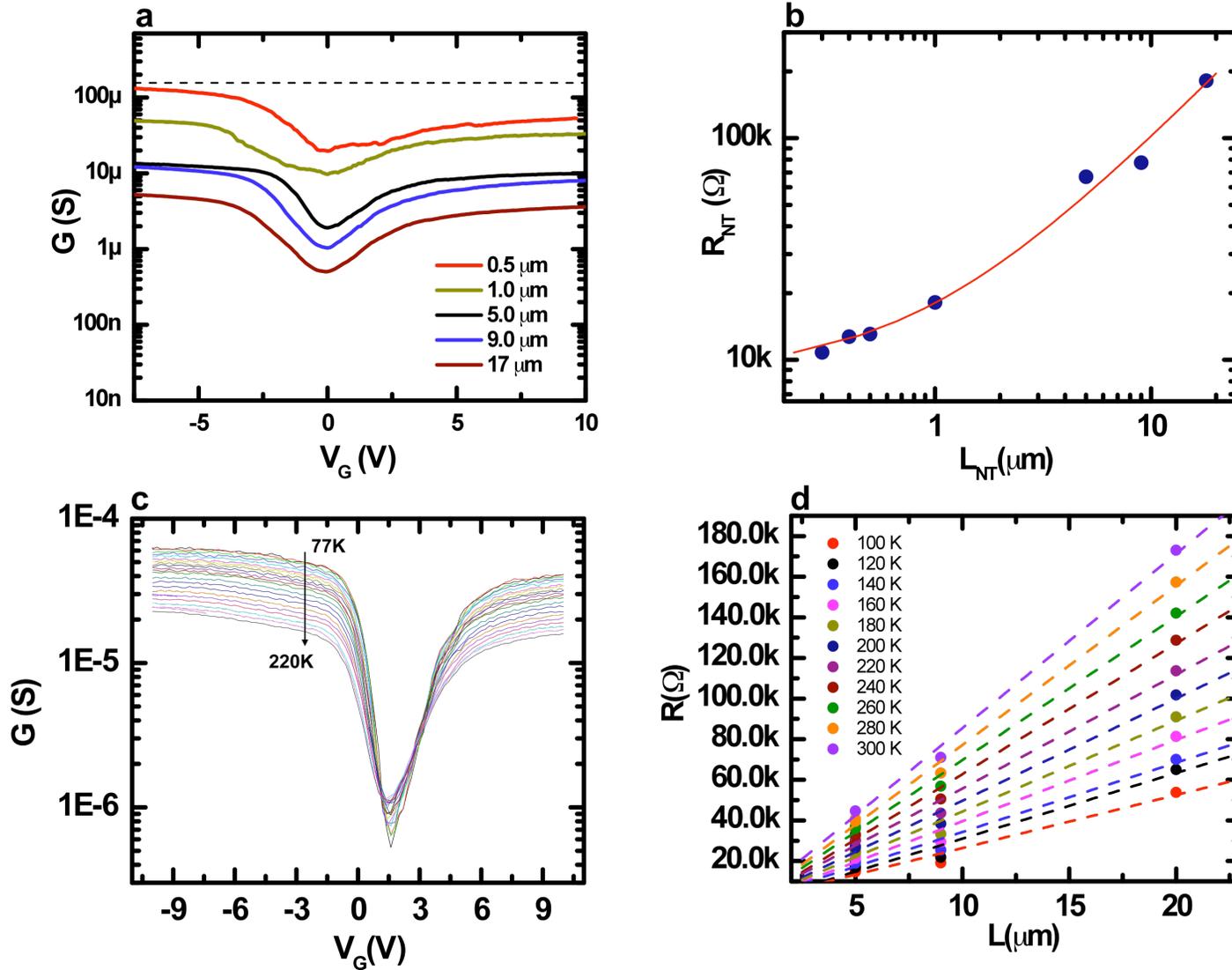
# Nanotube Heterojunction: Molecular Scale Quantum Dot



1. Bhupesh Chandra, Joydeep Bhattacharjee, Meninder Purewal, Young-Woo Son, Yang Wu, Mingyuan Huang, Hugen Yan, Tony F. Heinz, Philip Kim, Jeffrey. B. Neaton, James Hone, "Molecular-Scale Quantum Dots from Carbon Nanotube Heterojunctions," *Nano Lett.* **9**, 1544 (2009).

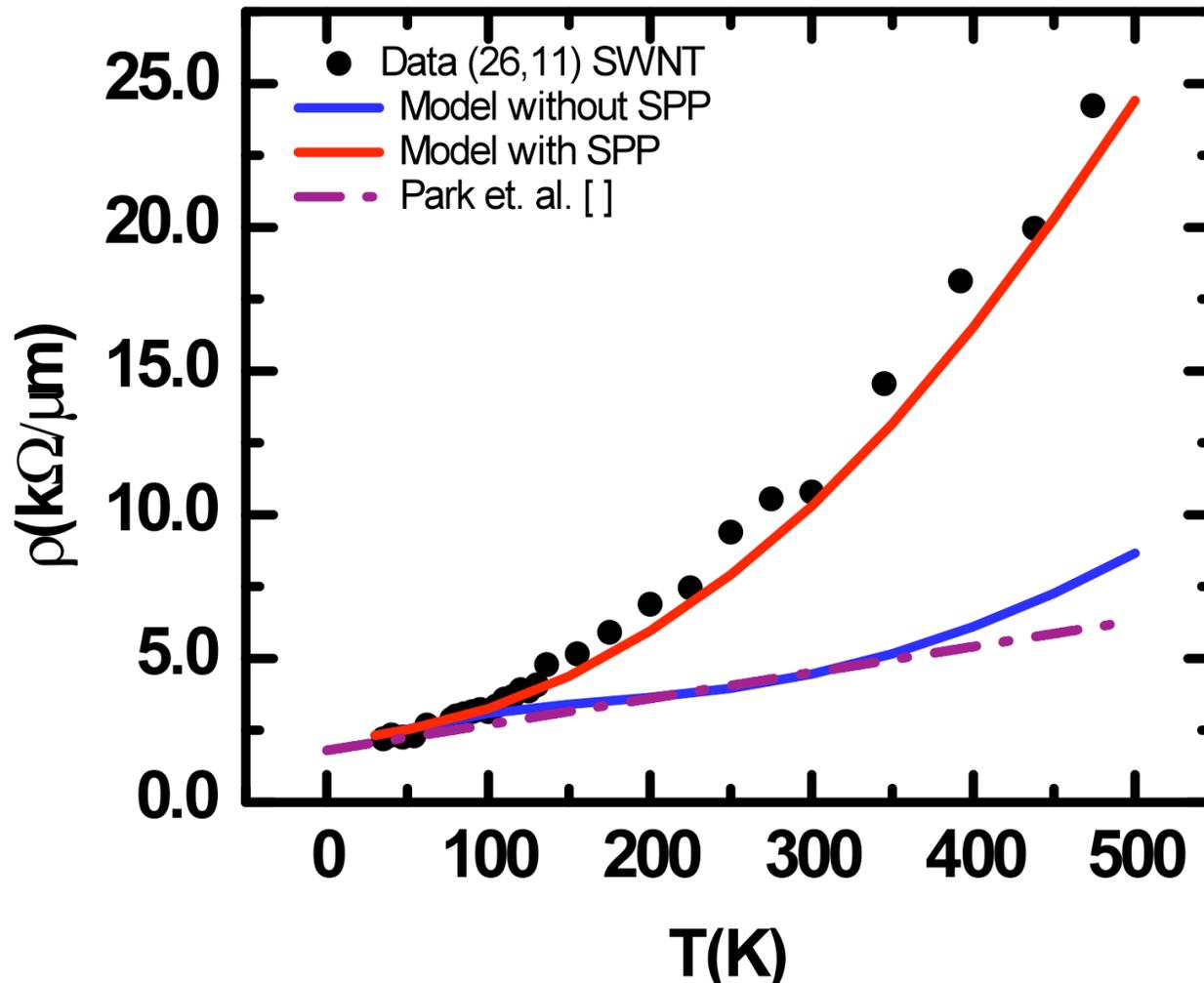


# Resistivity of known-chirality tube (26,11)





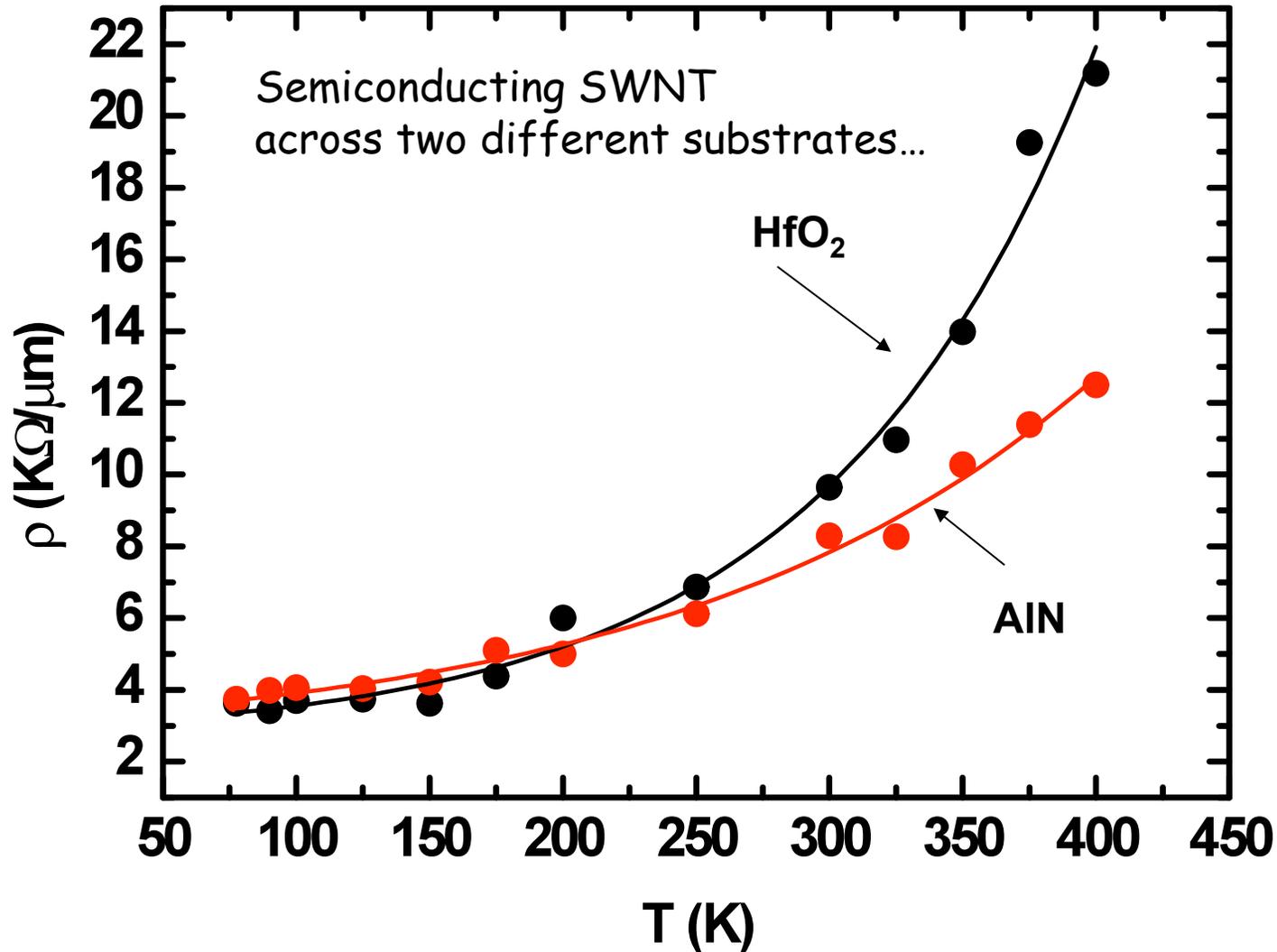
## Evidence for Substrate Effects



Surface Polar Phonons (SPP) are dominant scatterers at room T



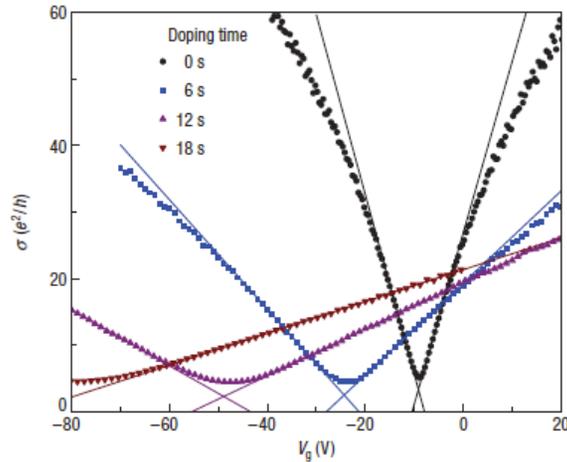
# Intrinsic and Extrinsic Resistivity



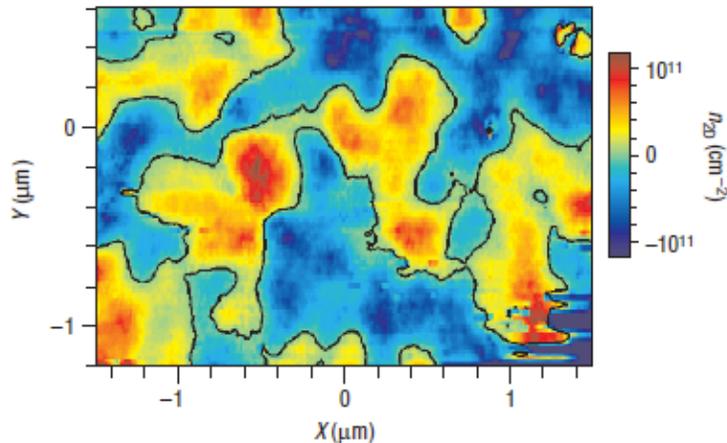
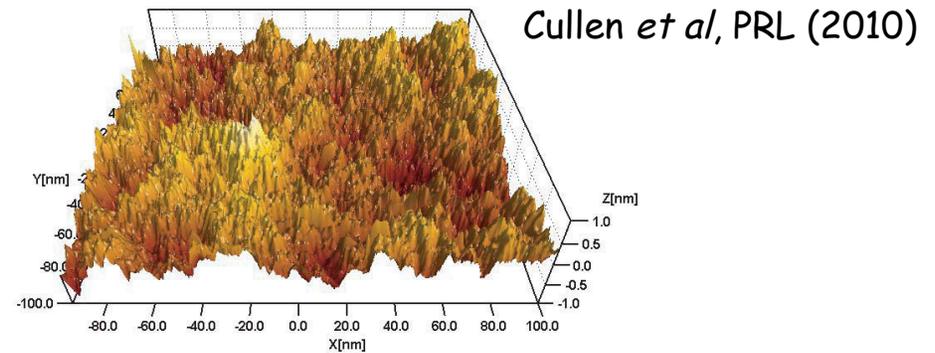


# Boron Nitride Substrates for Carbon Electronics

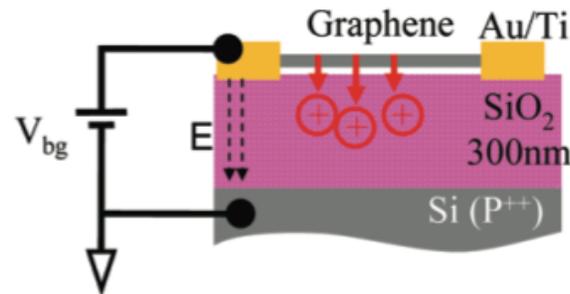
# Transport in Carbon Electronics: Substrates are a Problem



Chen *et al*, Nature Phys. (2008)



Martin, *et al*, Nature Phys. (2008)

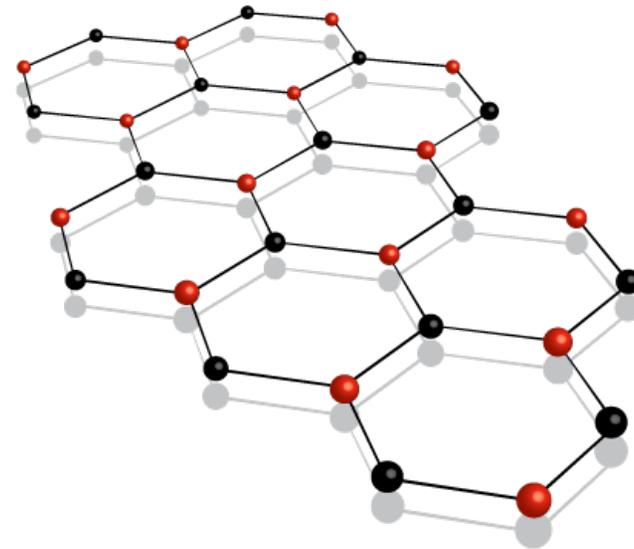
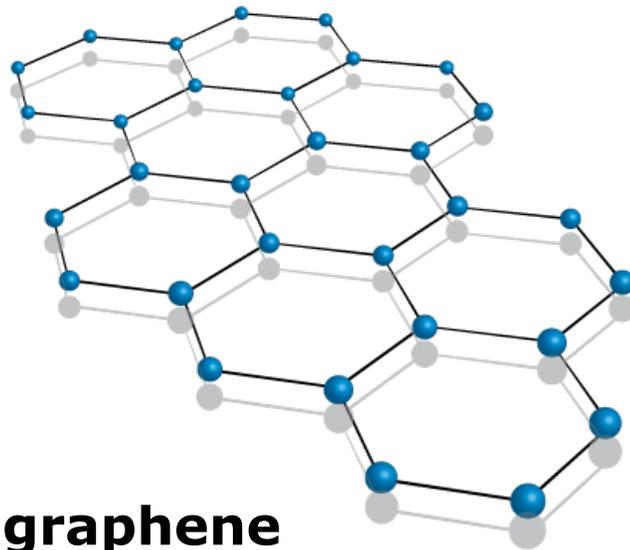


- mobility  $\sim 20,000$  cm<sup>2</sup>/Vs
- surface roughness
- charged impurity scattering
- potential disorder  $\sim 100$  meV
- large hysteresis

Ando (2006); Nomura and MacDonald (2007);  
Hwang, Adam and Das Sarma (2007)



# Boron Nitride - An Ideal Dielectric for Carbon Electronics?

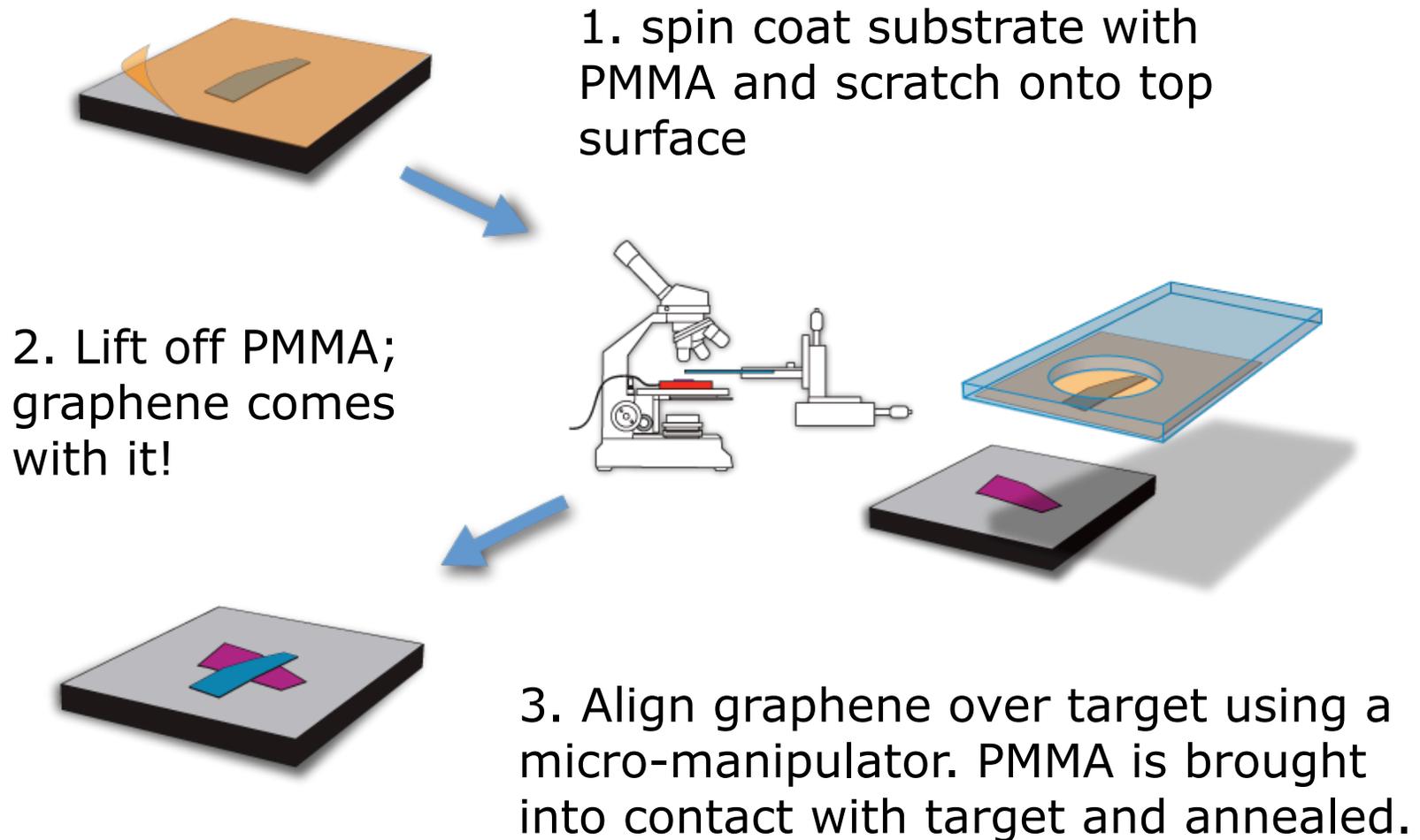


	Band Gap	Dielectric Constant	Optical Phonon Energy
BN	3.6 - 7.1 eV	~4*	>100 meV
SiO <sub>2</sub>	8.9 eV	3.9	59 meV

\*measured in our lab



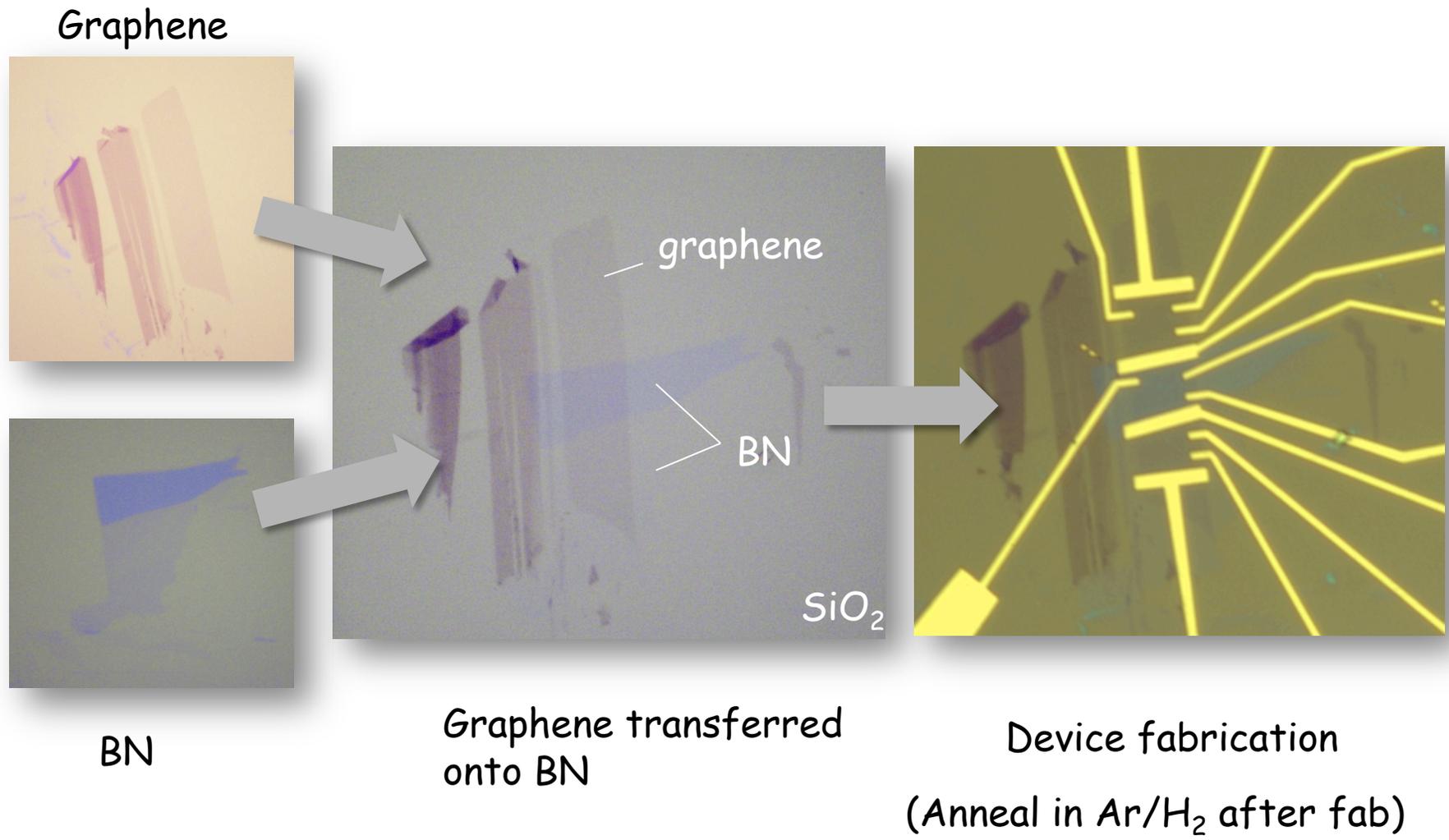
# Graphene/BN transfer



CC.R. Dean, A.F. Young, I. Meric, C. Lee, L. Wang, S. Sorgenfrei, K. Watanabe, T. Taniguchi, P. Kim, K.L. Shepard, J. Hone, Nature Nano (2010)



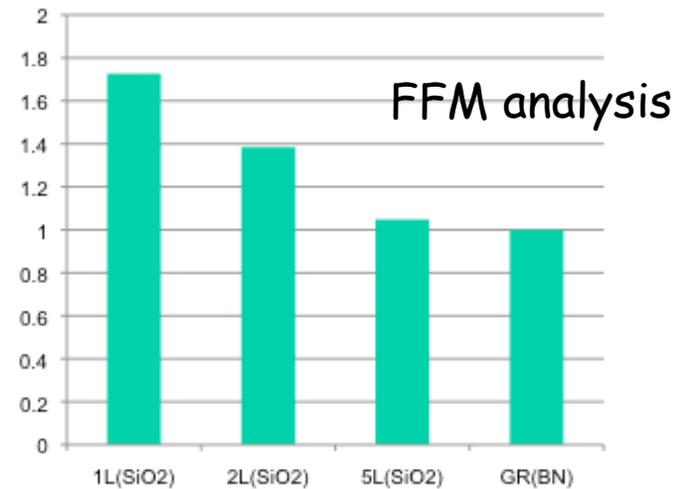
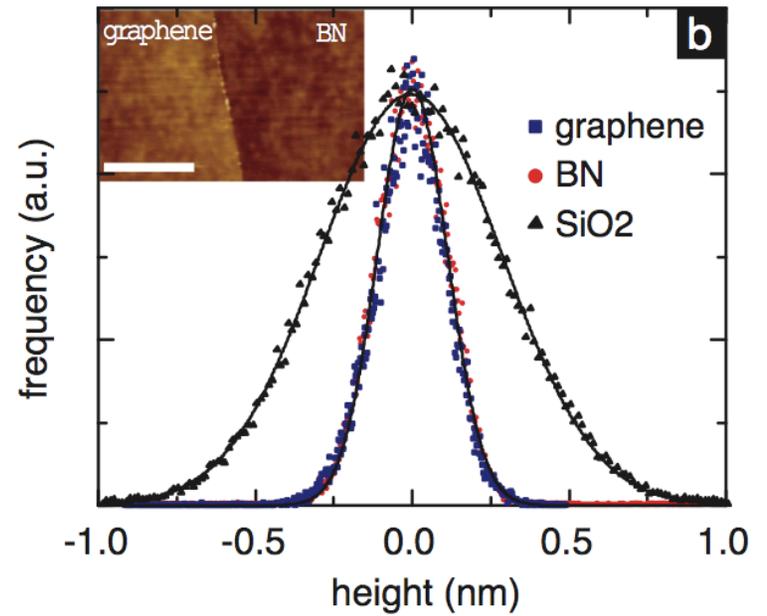
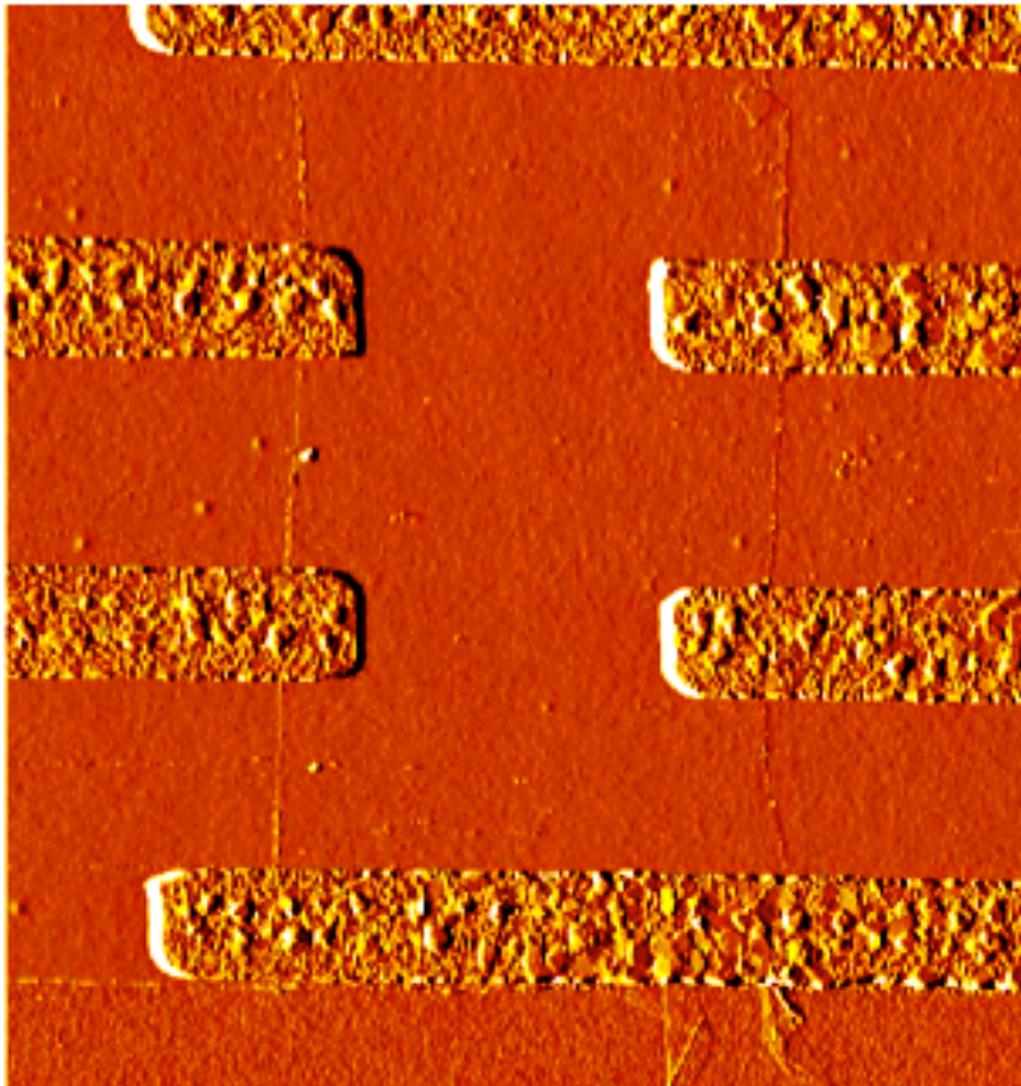
# Graphene/BN transfer



'Standard' devices: ~10 nm BN on 300 nm SiO<sub>2</sub>.

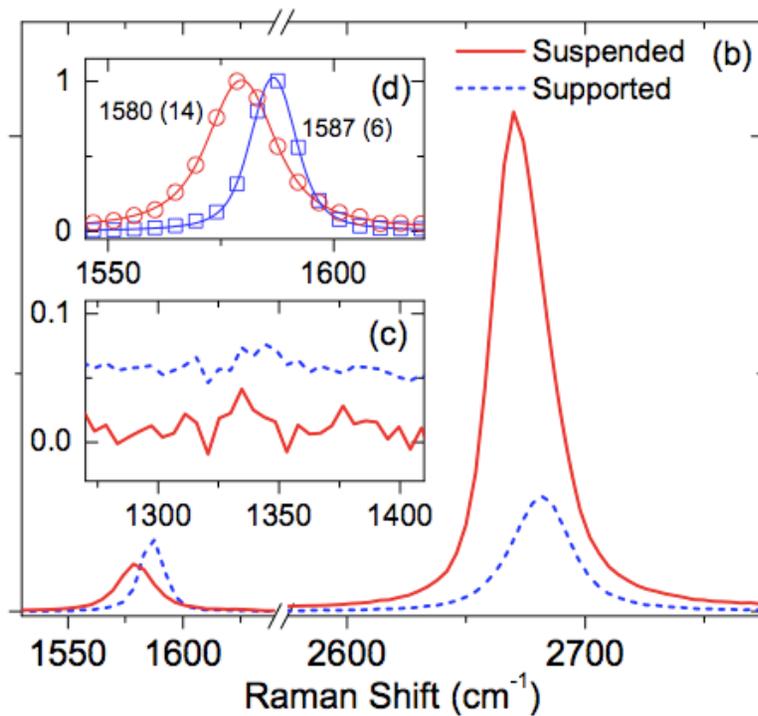


# Graphene on BN is very flat, and well-adhered!

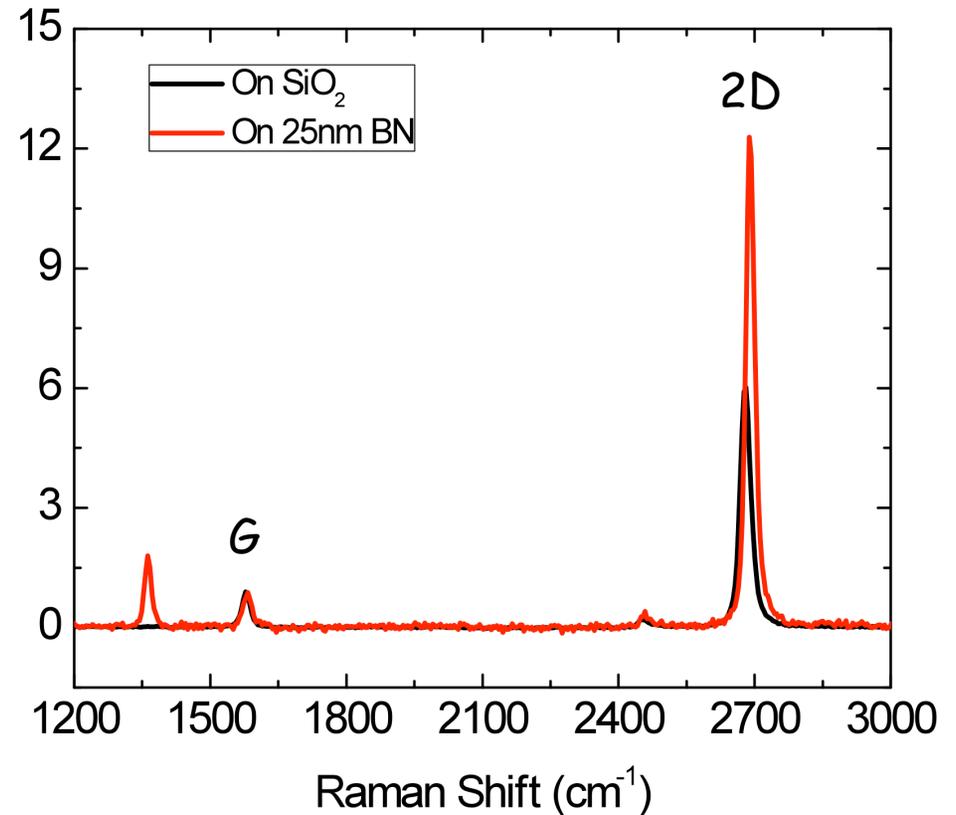




# Raman Spectroscopy



Suspended Graphene  
Berciaud et al, Nano Lett 2009

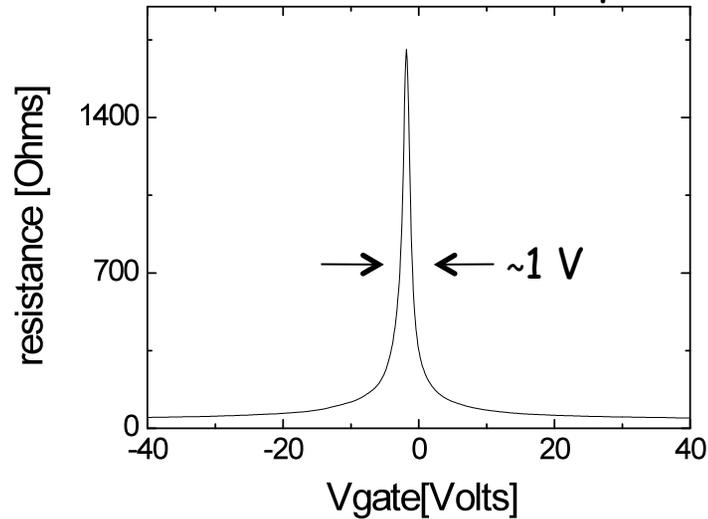


Increase in 2D / G ratio, similar to suspended samples

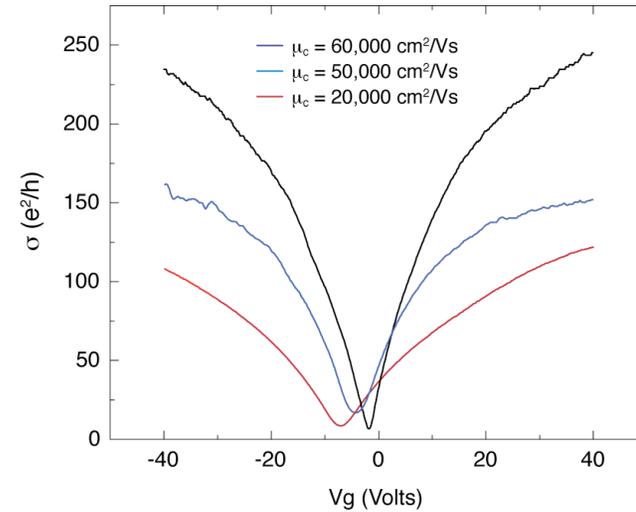


# Low-bias transport

## Zero field transport



## Comparison between devices



Conductivity

$$\sigma^{-1} = (ne\mu_C + \sigma_o)^{-1} + \rho_s$$

Mobility

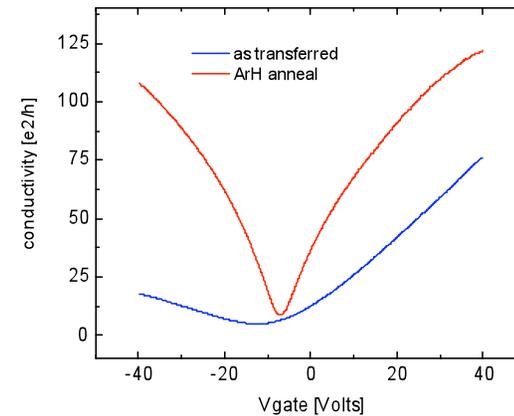
$$\mu_c \sim 60,000 - 100,000 \text{ cm}^2/\text{Vs}$$

$$\mu_{FE} \sim 20,000 - 30,000 \text{ cm}^2/\text{Vs}$$

Peak width

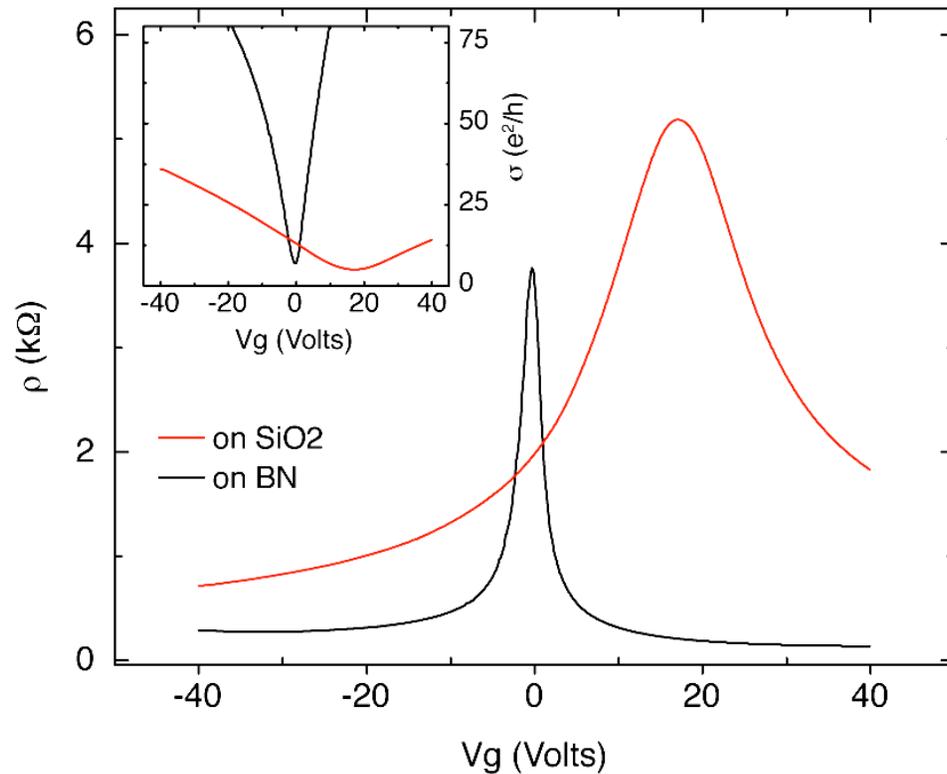
$$\delta\sigma \leq 10^{10} \text{ cm}^{-2}$$

## Effect of annealing



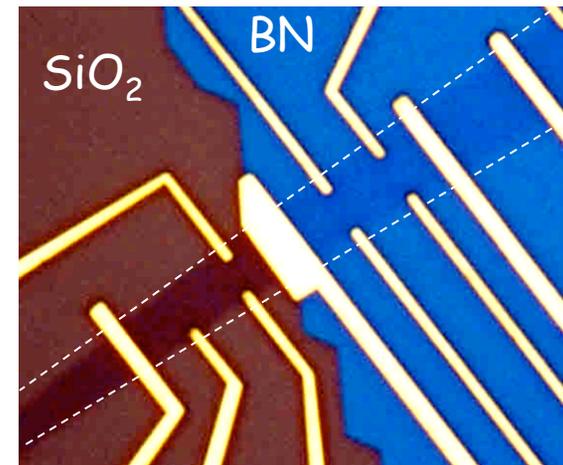


## Comparison to SiO<sub>2</sub>



	$\delta n$ (cm <sup>-2</sup> )	$n_{\text{max}}$
SiO <sub>2</sub>	$\sim 10^{11}$	$10^{13}$
Suspended	$\sim 10^{10}$	$1.5 \times 10^{11}$
hBN	$4 \times 10^{10}$	$10^{13}$

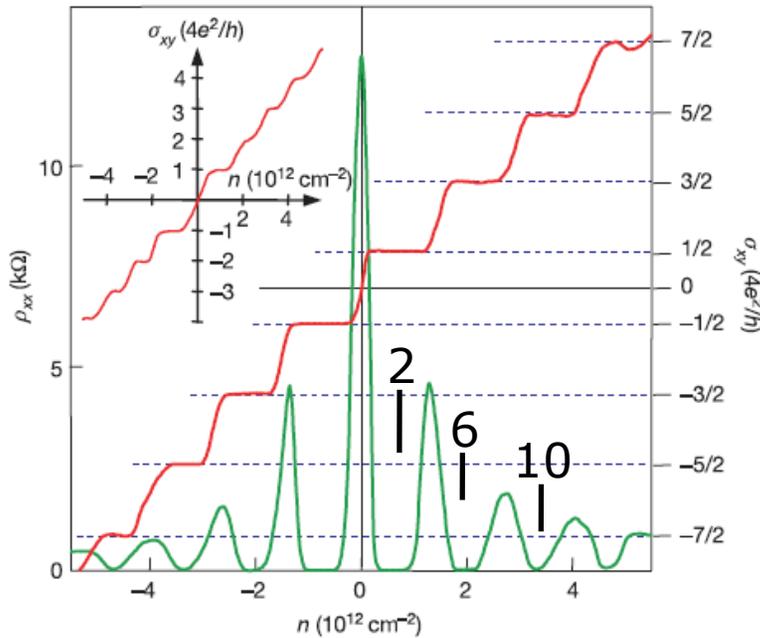
- greatly enhanced mobility on h-BN compared to SiO<sub>2</sub>
- CNP peak width reduced by nearly order of magnitude
- virtually no doping even after annealing
- virtually no hysteresis





# Integer Quantum Hall Effect

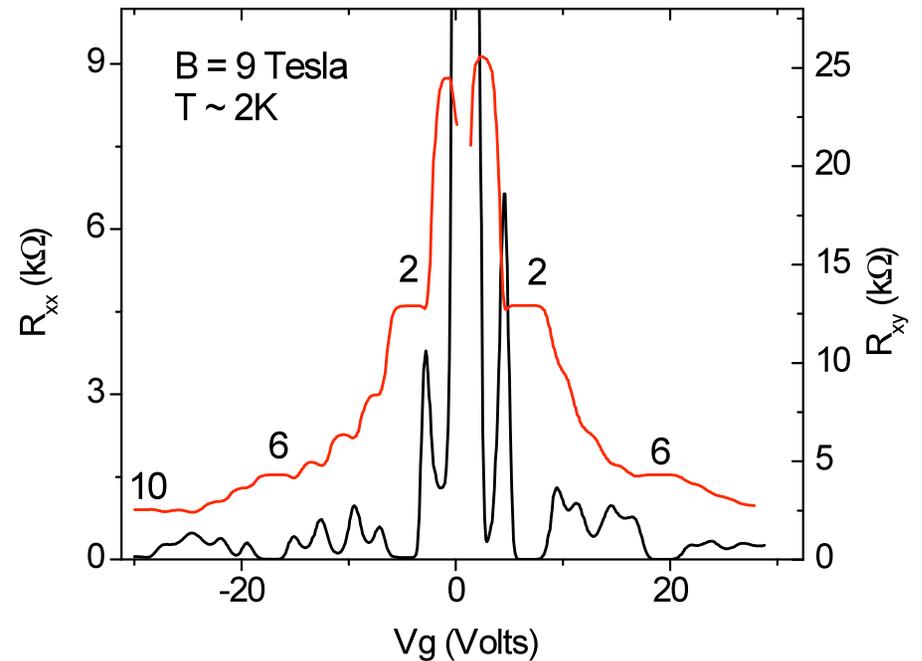
graphene on SiO<sub>2</sub>



$$\sigma_{xy} = \frac{4e^2}{h} \left( n + \frac{1}{2} \right)$$

“unconventional” QHE

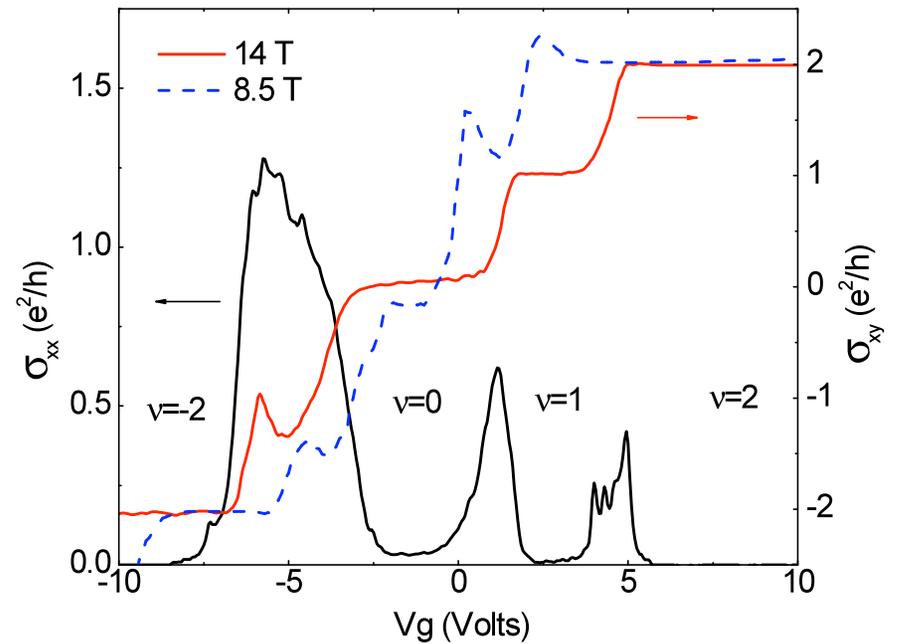
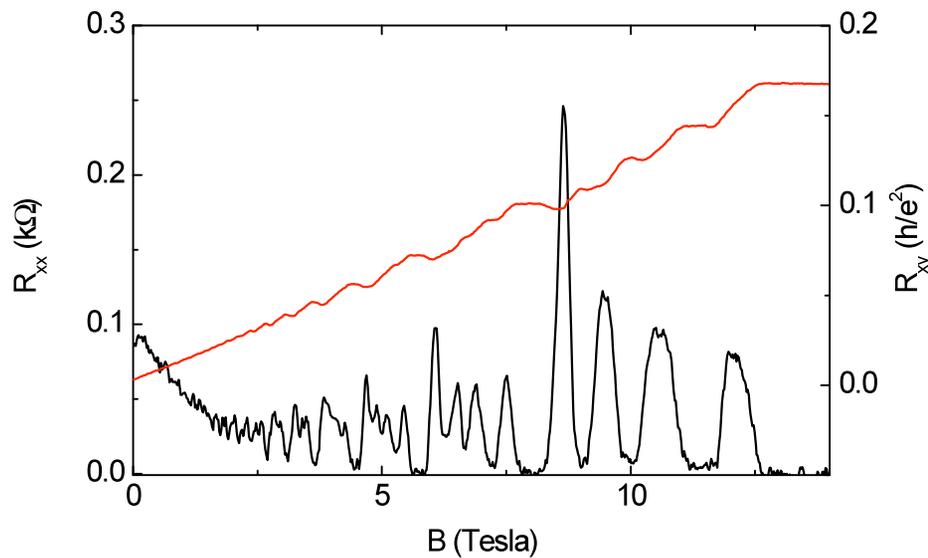
graphene on BN



see all integer QHE states!



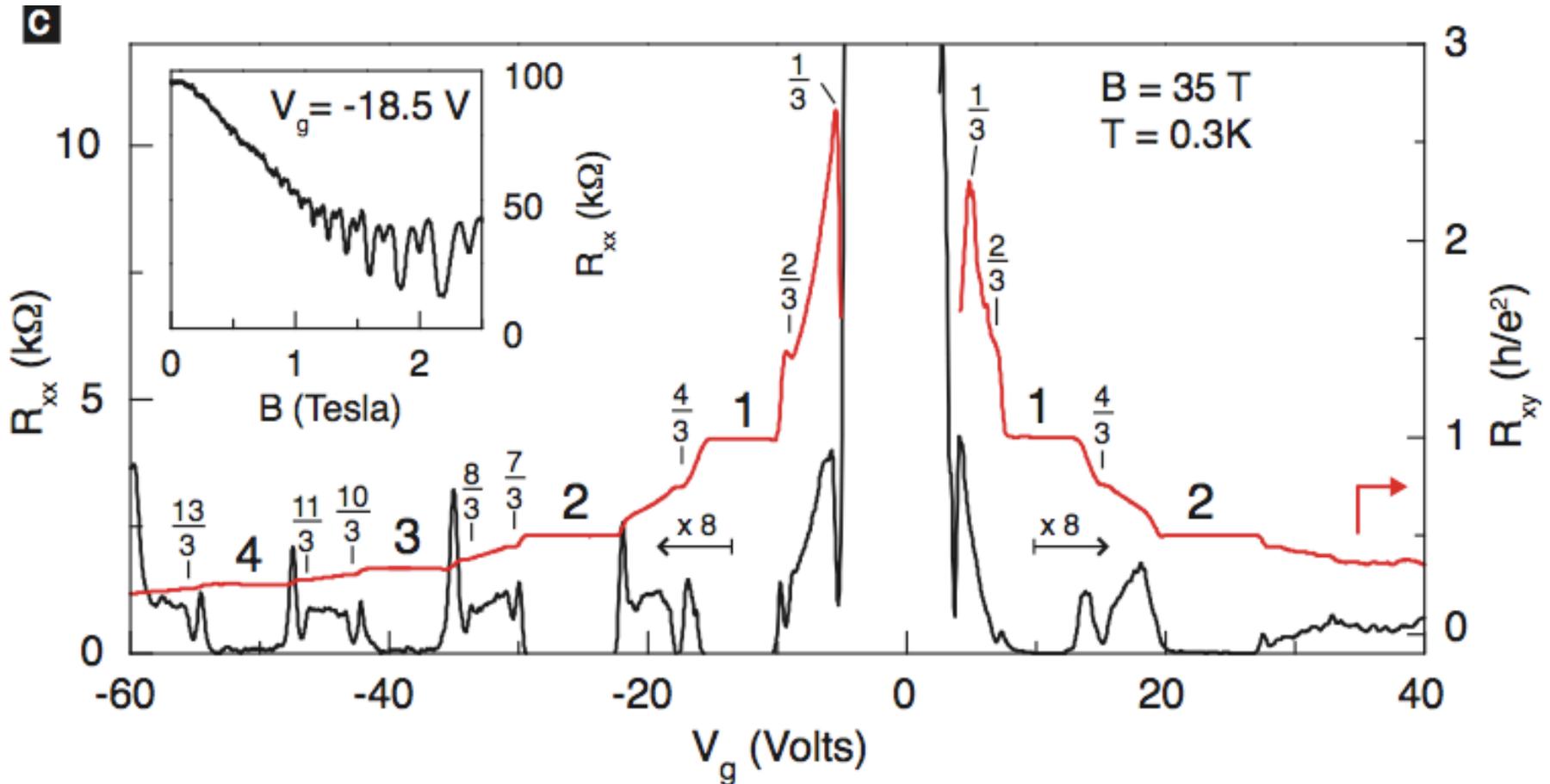
# Integer Quantum Hall Effect



On BN, the degeneracy of the Landau Levels is fully split...



# Fractional Quantum Hall

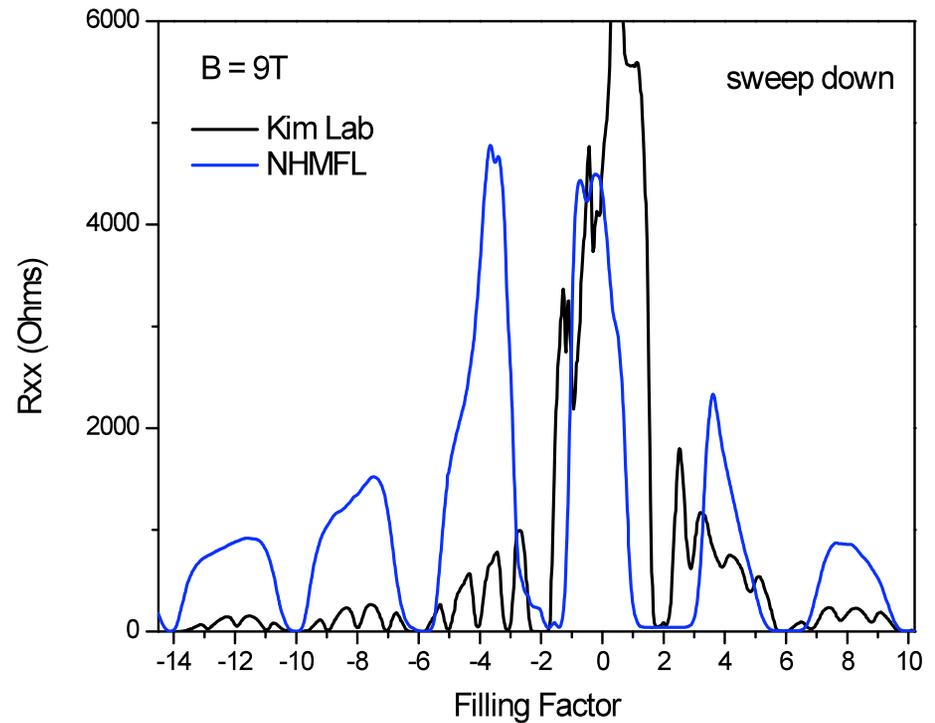
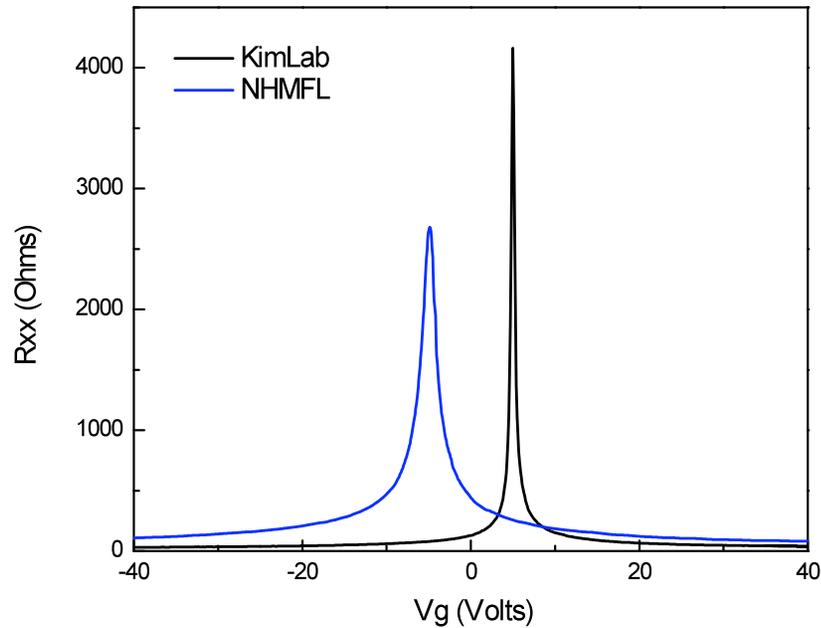


First FQHE on substrate-supported sample, 4-probe measurement  
Full set of fractions up to 13/3 (only 1/3 seen previously)

C.R. Dean, et al, Submitted



## Disorder from Contamination...



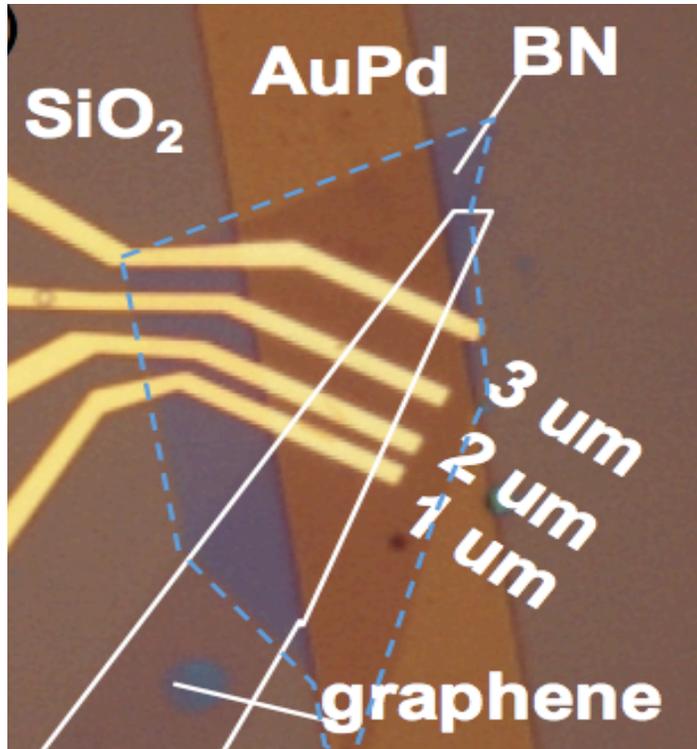
Pump oil contamination causes behavior similar to  $\text{SiO}_2$ .

- Doping
- Broadening of Dirac peak
- Loss of splitting of IQHE levels

Samples on BN are 'same' as those on  $\text{SiO}_2$ , just with less disorder...

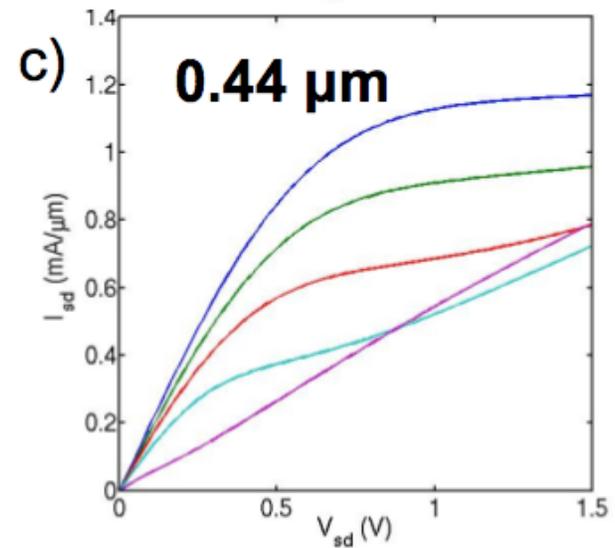
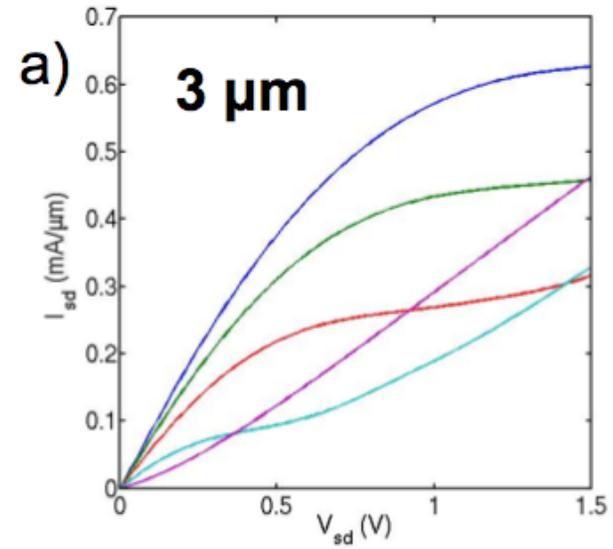


# High-Performance FETs



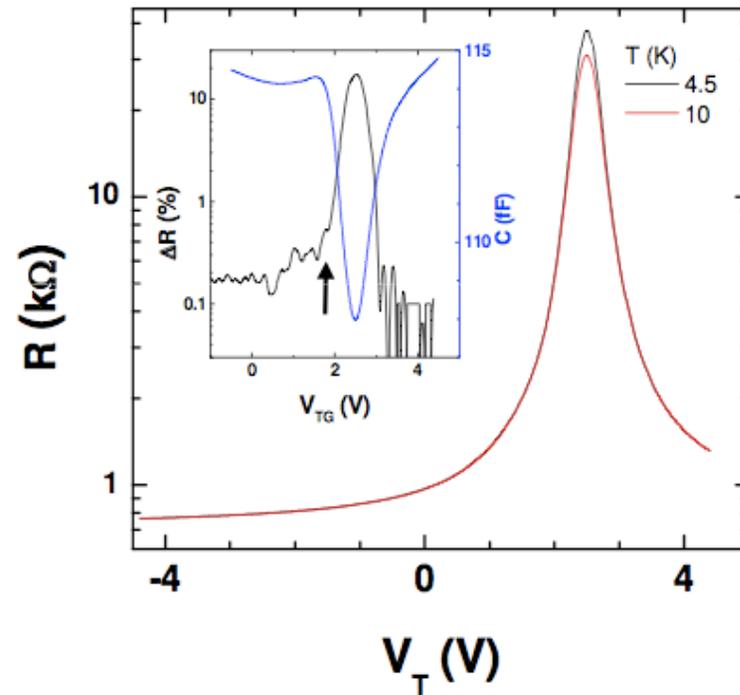
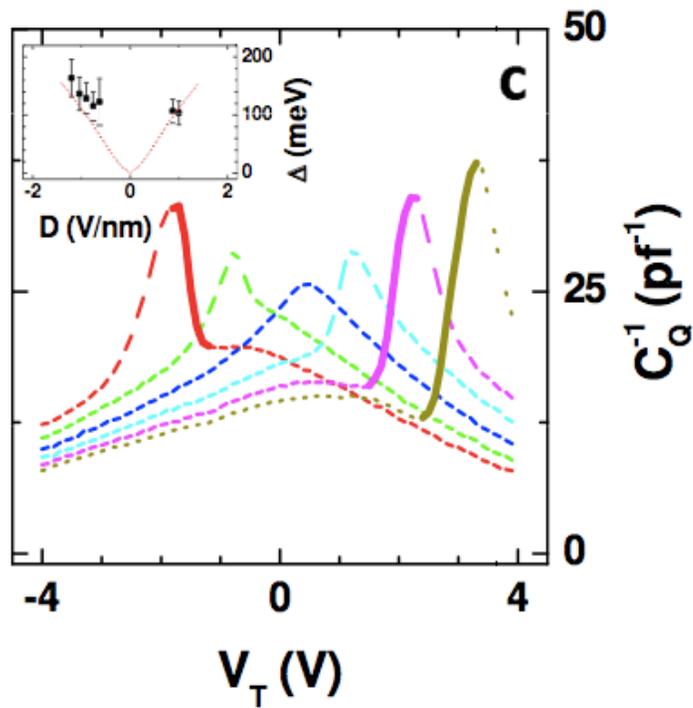
8.5 nm BN back gate

*Saturating sub-micron FETs...*





# Capacitance Measurements: Bilayer Graphene

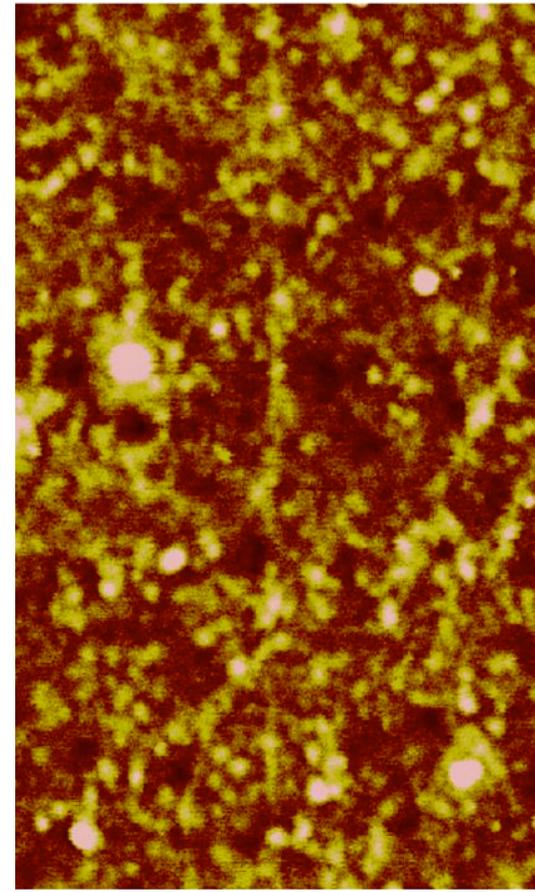
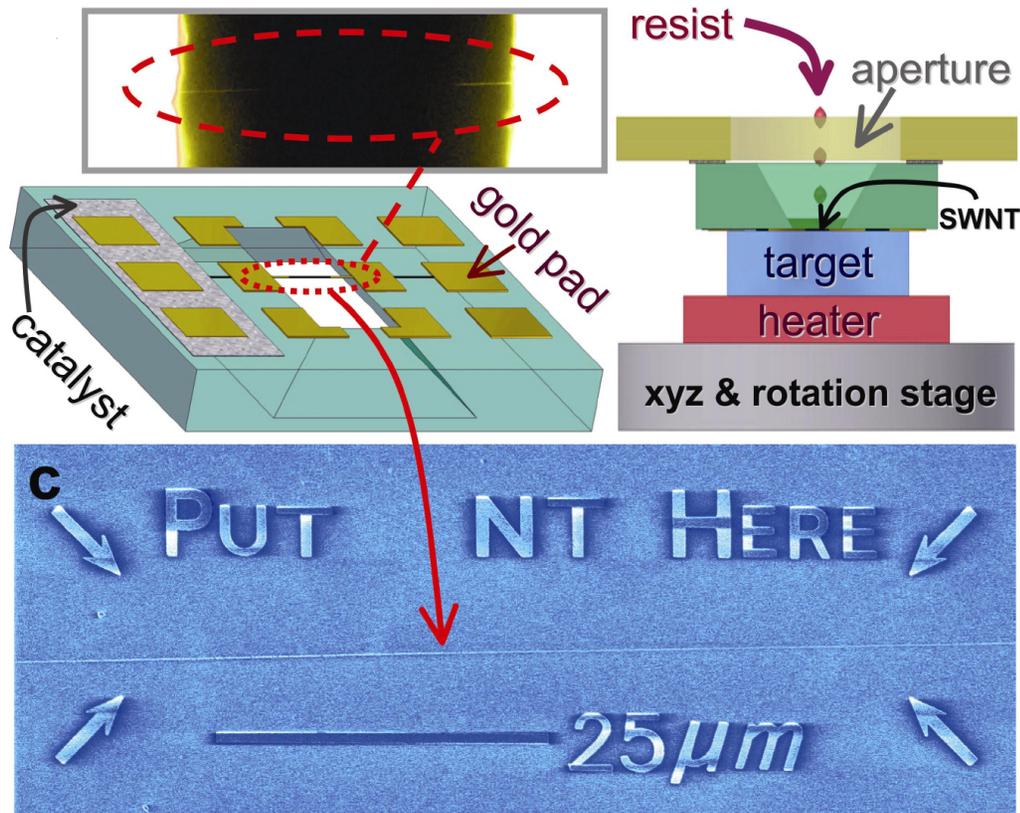


A. Young et al (submitted)



# Semiconducting Nanotube on BN

## Nanotube transfer technique

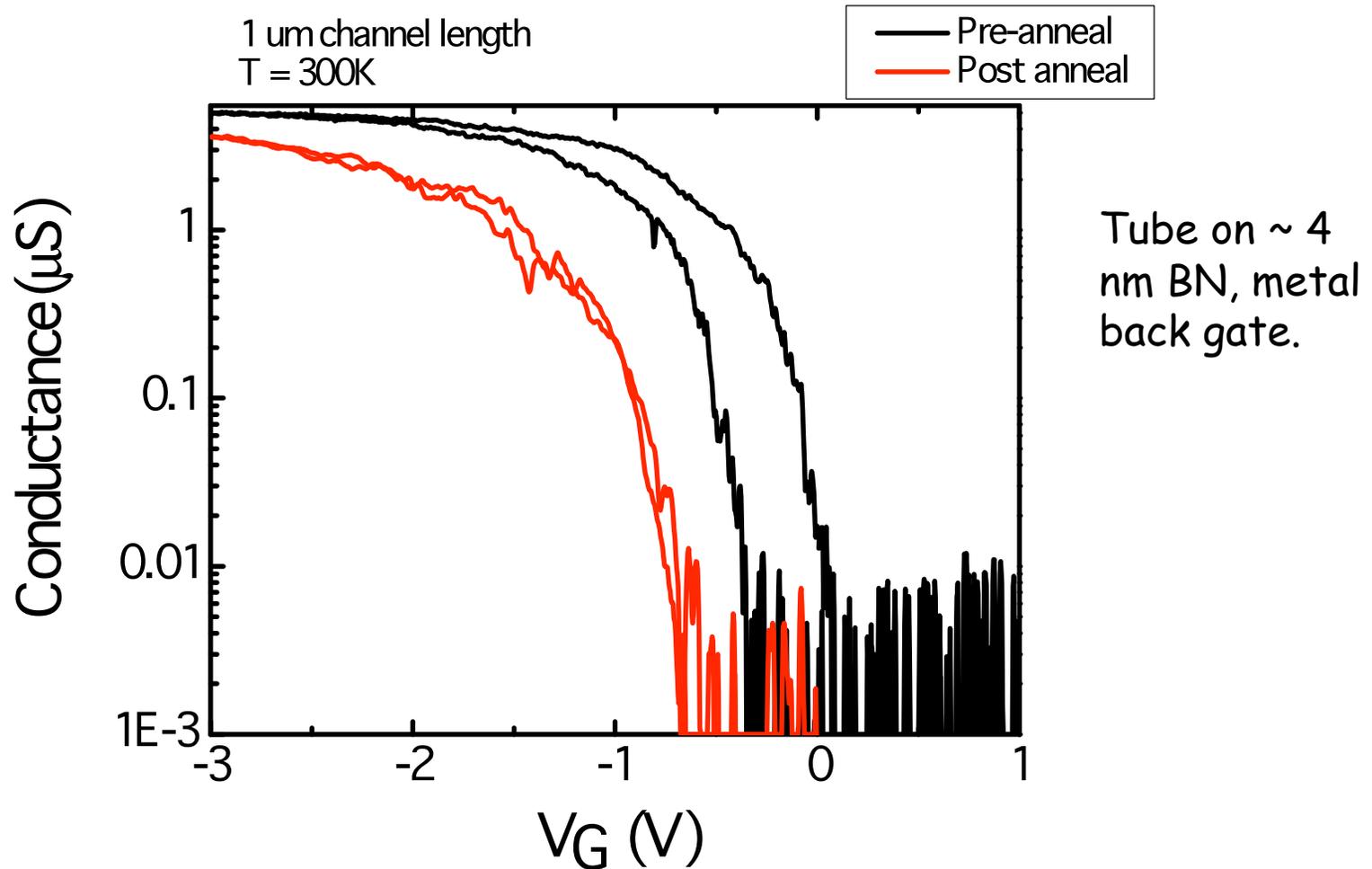


Huang *et al.*, Nano Letters 5, 1515 (2006)

AFM image of NT on BN:  
PMMA residue is problem...



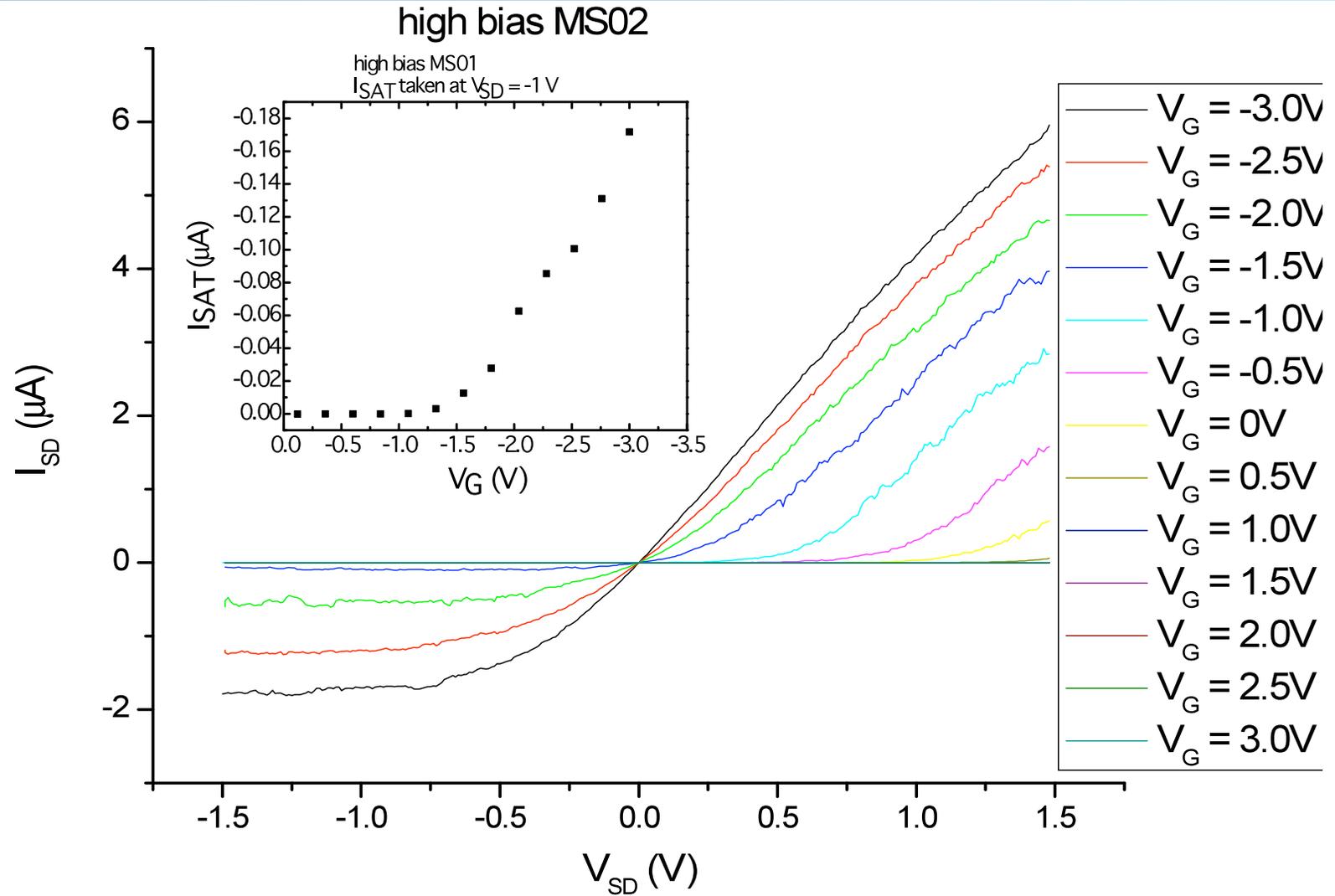
## Semiconducting Nanotube on BN



Virtually no hysteresis after annealing in vacuum (450 C)  
Subthreshold swing  $S \sim 170$  mV/decade (imperfect contacts)



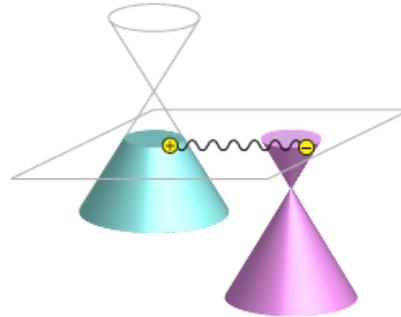
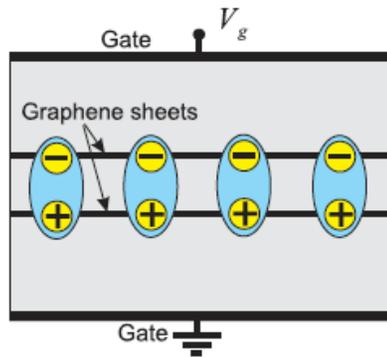
# Semiconducting Nanotube on BN



$V_{sat} \sim 2 \times 10^7$  (similar to on  $SiO_2$  see Chen and Fuhrer PRL 2005)

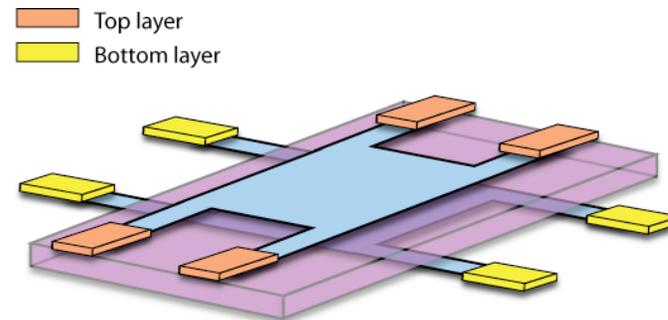
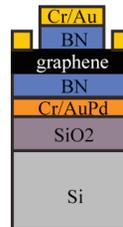
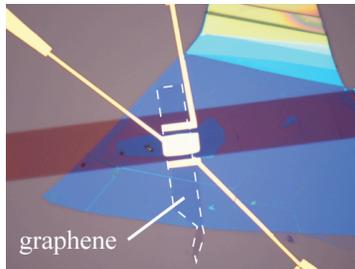


## Future: Multilayer Devices e.g. Exciton Condensation



### Requirements:

- double layer structure with small interlayer separation
- independent control of charge carrier type and density
- Very low scattering



H Min, R. Bestride, J.-J. Su, and A. H. MacDonald, PRB (2008):  $T_c \sim 300$  K

Kharitinov and Efetov, Semicond. Sci. Technol. (2010):  $T_c < 1$  mK



## Personnel and Funding

---

Hone group:

**Cory Dean** (with Shepard grp.)  
Bhupesh Chandra  
Lei Wang  
Rob Caldwell

Kim group:

Andrea Young  
Paul Cadden-Zimansky

Shepard group:

Inanc Meric  
Sebastian Sorgenfrei  
Natalia Baklitskaya

Takashi Taniguchi, Kenji Watanabe  
*National Institute for Materials Science, Japan*

Funding: NSF (NSEC); DARPA CERA; Intel; Honda